# CONTROL DATA 1700 COMPUTER SYSTEM 

1704-A/B, 1705-A, 1708-A<br>(Including Standard Options<br>10040-10043), AA101-A/B, AA1A1-A, AA1A3-A

## DIAGRAMS \& CIRCUIT DESCRIPTION CARD PLACEMENT

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## MANUAL TO EQUIPMENT LEVEL CORRELATION SHEET



## MANUAL TO EQUIPMENT LEVEL CORRELATION SHEET (CONT.)



## PREFACE

The 1700 Customer Engineering Manual provides logic diagrams and circuit descriptions of the CONTROL DATA ${ }^{\circledR} 1700$ Computer System. This manual contains information on all units contained in the main computer cabinet with the exception of the Basic Peripheral Equipment, which is in Pub. No. 60164200.

The circuit descriptions and diagrams are arranged to give a general continuity of logic flow. Thus, the Clock and Timing controls are given first, followed by the Register groupings, Adder/Shifter, etc. A special reference is made to the Command Timing sequences. These sequences give the detailed timing of each instruction. Thus, the Command Timing sequences logically interconnect various diagrams on a timed sequence basis. Refer to the 1700 Computer System Command Timing Charts, Pub. No. 60194500.

The logic diagram symbol description and the block diagram description precede the detailed circuit descriptions. The Logic Diagram Symbol section lists each of the standard logic symbols used on the diagrams and a brief description of their meaning and use.

## CONTENTS

Part 1. Diagrams
Main Computer
Block Diagram ..... 1
Clock - Normal Speed ..... 3
Clock - Slow and Fast ..... 5
Timing Chain ..... 7
Sequence Controls ..... 9
Cycle Control ..... 11
Addressing Controls ..... 13
Manual Controls (Sheet 1) (Register Selection and Clear Controls) ..... 15
Manual Controls (Sheet 2) (Switch and Indicator Drivers) ..... 17
Manual Controls (Sheet 3) (Test Mode and Run/Step) ..... 19
Manual Controls (Sheet 4) (Typical Register Display) ..... 21
F Register ..... 23
Function Translations (Sheet 1) ..... 25
Function Translations (Sheet 2) ..... 27
Function Translations (Sheet 3) ..... 29
A Register ..... 31
Q Register ..... 33
A, Q Fan-Out ..... 35
P Register ..... 37
X Register ..... 39
Y Register ..... 41
Y Decrementer and Skip FF ..... 43
Adder Controls (XR and LP) ..... 45
Adder Controls (Shift) ..... 47
Adder Gate Controls (Augend) ..... 49
Adder Gate Controls (Addend) ..... 51
Adder/Shifter Fan-In Augend Gates ..... 53
Adder/Shifter Fan-In Adder Gates ..... 55
Group 0 of Adder ..... 57
Adder/Shifter Groups 0 and 1 ..... 59
Adder/Shifter Groups 2 and 3 ..... 61
Adder/Shifter Groups 4 and 5 ..... 63
Adder/Shifter Groups 6 and 7 ..... 65
Optional Mask and Interrupt Registers and Receivers ..... 67
Program Protect and Interrupt ..... 69
Mask Register and Interrupt Priority ..... 71
Shift , MUI, and DVI Controls ..... 73
AQ I/O (Part 1) ..... 75
AQ I/O (Part 2) ..... 77
Storage
Block Diagram 1700 Storage ..... 79
S Register ..... 81
Z Register (Stages 0 and 1) ..... 83
Z Register (Stages 2 and 3) ..... 85
Z Register (Stages 4 and 5) ..... 87
Z Register (Stages 6 and 7) ..... 89
Z Register (Stages 8 and 9) ..... 91
Z Register (Stages 10 and 11) ..... 93
Z Register (Stages 12 and 13) ..... 95
Z Register (Stages 14 and 15) ..... 97
Z Register (Stages 16 and 17) ..... 99
Storage Interface ..... 101
Storage Timing Chain ..... 103
Storage Timing and Control (Sheet 1) ..... 105
Storage Timing and Control (Sheet 2) ..... 107
X and Y Drive Decks ..... 109
Inhibit Drive Decks ..... 111
Transfers
Addressing Modes ..... 113
Addressing Modes ..... 115

## CONTENTS (Cont'd)

STO Transfers ..... 117
REG Transfers ..... 119
ROP Transfers ..... 121
B Cycle Transfers ..... 123
C Cycle Transfers ${ }^{\circ}$ ..... 125
Power and Cabling
Power Distribution, Vertical Auxiliary Cabinet ..... 127
Power Control Panel ..... 129
Monitor Panel ..... 131
Power Distribution Box Schematic ..... 133
Wiring Diagram ..... 135

MAIN COMPUTER

## LOGIC DIAGRAM SYMBOLS

Two signals, a logical " 0 " and a logical " 11 ", are the possible input or output conditions of a circuit. By convention, " 1 " is considered "up" and " 0 " is conconditions of a circuit. By convention, "is considered up and " 1 is consymbols and their associated electronic representations are contained in the Printed Circuits Manual, Vols. 3 and 4.

STANDARD LOGIC SYMBOLS
The 1700 Computer logic is mainly composed of the CONTROL DATA 6000 Series printed circuit modules. Standard logic diagram symbols for this typ of printed circuit modules are inverters, test points, flip-flops, and twisted pair line drivers.

## INVERTERS

An inverter is a logic element which provides an output that is an inversion of its input. When an inverter receives more than one input, "0's" take precedence over "1's" and drive the output of the inverter to "1". Because all of the several inputs have to be " 1 " to drive the output of the inverter to a " 0 ", the inverter may be considered an inverting AND (or NAND) gate when more than one input is present. Logic diagrams show the basic inverter as an arrow into either a circle or a square (see Figure 1). Both symbols represent the same electronic circuit and have the same logical interpretation. In a logic sequence of inverters, circle and square symbols are usually alternated as an output from subsequent squares in the logic chain if each symbol in the chain has only one input.

Acceptable conventions for showing multiple inputs and outputs are given in Figure 2. Note that the output of inverter A is " 0 " only if inputs X, Y, and Z are all " 1 ". The multiple outputs are identical

Figure 3 shows an example of an inverter network. Because multiple output are identical, Figure 4 shows only one arrow in cases where an inverter (A) serves as the single input to several succeeding inverters. In more complex inverter networks, multiple arrows are used ( $B$ to $C$ and $D$ because $B$ is not the only input to $C$ or D)

## $\rightarrow *$ <br> - denotes special text reference

Figure 1. Inverter Symbols


Figure 2. Multiple Inputs/Outputs


Figure 3. Invèrter Networks

## TEST POINTS

A test point performs no logic function. Logic diagrams show the test point a triangle (see Figure 4). Test points are numbered from 1 to 6


Figure 4. Test Point Symbols

## FLIP-FLOPS (FF)

The flip-flop is composed of two inverters and functions as a storage device with two stable states designated as set and clear (see Figure 5). The fliplop is set when the set output ( $B$ ) is a " 1 " and clear when it is a " 0 ". Note that the input (A) must be " 0 " to set the flip-flop, and (C) must be " 0 " to clear it.


Figure 5. Flip-Flop Symbol

## WIRE TAB DESIGNATIONS

Wire tab designations written next to a in indicate where in the drawings the in is connected. 3,5, 7 - C37-6 nodule C37, found on with pin 5 of
7. See Figure 5.1 .

## PAGE LOCATION PIN <br> 3,5,7 C37 6

( X IN PLACE OF PIN NUMBERS
DENOTES GROUND

Figure 5.1. Wire Tab Designations

## TWISTED PAIR DRIVERS

A Line Driver circuit transmits logic signals from one module to another. Module are connected by twisted-pair lines. The standard square or circle represents the twisted-pair driver. However, the output of the square or circle connects to a pin of the module. The pin is then wired to a pin on another module (see Figure 6). The pins are represented by small circles and are numbered from 1 to 28 . (Pins 29 and 30 are ground and +6 volts, respectively and generally re not thown in logis diagrams.) The module location is shown above the card, and the module type is denoted in the upper right-hand corner.


Figure 6. Twisted-Pair Line Driver
RECEIVER/TRANSMITTER CIRCUITS
The Receiver and Transmitter circuits detect and transmit signals from and to I/O interface respectively. The Receiver and Transmitter circuits are modifications of the standard 3000 Series circuits of the same name. These circuits are contained on a printed circuit module along with the standard inverter circuits.

Figures 7 and 8 shows that Receiver and Transmitter circuits are represented by the square symbol with an " $R$ " or " $T$ " respectively. The two inputs to the receiver are each connected to two pins on the module

In Figure 7, a " 1 " input to $R$ is inverted, causing a " 1 " output from pin 6 and a " 0 " In Figure 7 , a in 13 . Thus, with a " 1 " input, the Receiver circuit produces both True and Not outputs.

The Transmitter circuit receives a " 1 " input signal from a standard inverter or FF and transmits a " 1 " output signal to the I/O interface. In Figure 7, a " 1 " input to and transmits a output signal to the I/O interface. In Figure


Figure 7. Receiver / Transmitter Circuit Examples


In addition to the standard symbols, the diagrams also use symbols representing special nonstandard circuits. The symbols for these circuits along with a brief description are given below.

Special variations of the standard building block are indicated by the symbols shown on Figure 9. The symbol and schematic for the corresponding special circuit are shown on the applicable logic diagram and also on the module schematic in the Printed Circuits Manual.


Figure 9. Special Circuits

## CAPACITIVE DELAY CIRCUITS

Capacitive Delay circuits delay input " 1 " signals a prescribed time before issuing an output " 1 " signal. The 1700 uses both fixed and variable delay circuits. Figure 10 shows examples of both types. The delay time of the circuit and capacitor value are listed beside the capacitor symbol. The variable potentiometer enables adjustment of the delay time of the circuit within certain limits.

fixed delay

variable delay

Figure 10. Capacitive Delay Circuits

## BLOCK DIAGRAM

The block diagram shows the main circuits in the 1704 Arithmetic and Control portion of the CONTROL DATA 1700 small industrial computer. The I/O and memory interfaces are indicated.

As shown, the 1704 consists mainly of registers, the adder/shifter network, and control circuits. In general, the registers contain quantities for some period of time. When the quantities require an Arithmetic, Logical, or Transfer operation, they are transmitted through the adder/shifter network. The adder/shifter combines the quantities with one another in a Logical or serves as a path for the contents of one register to transfer to another register Thus, the adder/shifter serves as the main path for all Arithmetic, Logical, or Inter-kegister Transfer operations.

## MAIN REGISTERS

The function of the main registers shown on the block diagram is briefly described in the following paragraphs.

## Z REGISTER

The 18 -bit $Z$ register temporarily stores all data words being read from or written into storage. Bits 16 and 17 are not part of the data but are the program protect and parity bits respectively. Control operates on these bits independently rom the data bits.

In a Read Memory operation, the 16 data bits transfer to the $X$ register. In a Write operation, the data bits to be written are transferred from $X$ to $Z$ register

## X REGISTER

The 16 -bit $X$ register holds the data bits transferring to or from the $Z$ register. This register holds one of the parameters in most Arithmetic operations. When he $X$ register contains an instruction, the high-order 8 bits transfer to the $F$ register for translation

## F REGISTER

The 8 -bit F register contains the instruction code and/or addressing mode bits. The translation of these bits direct the execution of the instructions.

Y REGISTER
The 16 -bit Address register contains the storage address for transfer to the S register during a storage reference. The Y register in conjunction with the Y Decrementer also functions as a counter during the multiply and shift during address modification and the final effective address when modification is complete.

## S REGISTER

The 15 -bit Storage Address register contains the effective storage address transferred from the $Y$ register or from the external storage access. All address selection for internal storage access is controlled by the contents of the $Y$ register.

## P REGISTER

The $15-$ bit $P$ register contains the program address of the instruction currently being executed. In the later stages of instruction execution, except in certain Jump and Skip instructions, the P register is advanced by adding +1 in the adder/shifter network for referencing the next instruction.

## A REGISTER

The 16 -bit A register functions as the principal register in most Arithmetic The 16-bit A register fun

## Q REGISTER

The 16 -bit $Q$ register serves as the auxiliary register in most Arithmetic and Logical operations.

## MASK REGISTER

The 16 -bit Mask register contains the interrupt mask bits. Each"bit in the Mask register corresponds to a particular interrupt line. In order for a particular type of interrupt to be recognized when it occurs, the corresponding bit in the Mask register must be a " 1 ".

## ADDEND/AUGEND GATES

The addend/augend gates serve as the input gate control for the adder/shifter In most Arithmetic, Logical, or Register Transfer operations, one input is selected by the addend gates and one by the augend gates. Thus, four inputs are applied to addend and augend gates respectively.

## ADDER/SHIFTER

The adder/shifter performs all Arithmetic and Logical operations on the register contents. The adder/shifter also serves as the transfer path for all Inter-Register Transfer operations.

## MAIN CONTROL

The main control circuits are shown on the right side of the block diagram.

## MANUAL CONTROLS

The manual controls consist of the start, stop, manual set, and indicator control circuits. Thus, the manual controls initiate all start, stop, and manual selection operations in the computer.

## CLOCK

The clock circuit produces 4 -phase, $25-$ nsec clock pulses which form the timing base for all control operations in the computer.

TIMING CHAIN
With an input from the clock and manual controls, the timing chain produces a series of eight controlled $25-\mathrm{nsec}$ timing pulses at $50-\mathrm{nsec}$ intervals.

## SEQUENCE CONTROL

The sequence control circuit controls the mode of operation for the execution of a given instruction. There are five general modes of operation:

1) Read Next Instruction (RNI)
2) Address Mode (ADR)
3) Read Operand (ROP)
4) Store Operand (STO)
5) Register Transfer Mode (REG)

The execution of an instruction may pass through two or more modes of operation. All instructions begin in the RNI mode and then enter one or more of the other modes in sequence

CYCLE CONTROL
Three main timing cycles control instruction operation: the $\mathbf{A}$ cycle, B cycle, and C cycle. The A cycle begins with an initial start or resume from storage. The A cycle cycle. The A cycle begins with an initial start or resume from storage

The B cycle is initiated immediately after the A cycle except in multiply, divide, and shift operations. The B cycle initiates storage operations.

The C cycle begins after the A cycle and performs multiply, divide, or shift cycle iterations.

## REGISTER TRANSFER CONTROLS

This circuit controls the transfer of registers in the computer based on the cycle, sequence mode, and instruction being executed.

## ADDRESSING CONTROL

This circuit controls the modification of the address in storage reference instruction. The addressing control circuit receives inputs from cycle control, sequence control, and the address control bits in the instruction.


## MASTER CLOCK - NORMAL SPEED

Timing in the 1700 is controlled by a 4-phase master clock. Four. 25-nsec pulses are issued each minor cycle to control movement of data and instructions.

The master clock oscillator consists of a TD module and a V50 module. To form the $25-$ nsec pulses, a pulse from the TD is ANDed with a similar pulse which has
been delayed and inverted by the V50. The result is a series of pulses (primary clock) which are fanned out through V31 and TC modules to be used as timing control.



The master clock pulse rate may be increased or decreased by substitution of a V51 or V52 in place of a V50 module. The V51 module has a longer oscillator loop than the normal V50 module.

The V52 module has a shorter oscillator loop which increases the clock speed by shortening the wires between the TD and V52 module.

The V51 and V52 modules are for maintenance only and can not be used for normal computer operation.


## TIMING CHAIN AND CONTROL

The timing chain for the 1700 Computer consists of two V 69 modules. Each module contains four FFs connected together, forming a chain of eight FFs (H00-H07). Each FF is gated by a clock pulse. As a "1" passes down the chain, each FF is set for 75 nsec . The FFs alternately set at t00 and t50 and clear at t 25 and t 75 , thus overlapping each other by 25 nsec . Normally, the total cycle time for one pass of the timing chain is 400 nsec . The exception is explained below under Short Cycle 1.

The timing chain enables the V000-V350 $25-\mathrm{nsec}$ pulses. The V pulses occur at t00 and t50, simultaneous to the setting of the timing chain FFs.

T pulses, V pulses, and H--FFs control computer timing, with the exception of storage control. Storage control uses a separate timing chain consisting of K--FFs.

Shown on the top of page 7 are a number of fan-outs for the timing chain. The fanouts are shown as partial modules, because they are included on modules of un-. related logic.

## SHORT CYCLE 1

During Multiply and Shift instructions, time 250 occurs 100 nsec early. This sequence occurs only during the C cycle when the Short Cycle 1 (SC1) signal is present. FF H02 sets at time 100, but an SC1 signal blocks the setting of H03 at time 150. Instead, the H02 enable leaves module V69 through pin 5 and enters the second V69 module at pin 25 . The SC1 signal at pin 23 enables the setting of H05 at time 250. FFs H03 and H04 are not set during the SC1 condition.

## START TIMING CHAIN

Initially, the timing chain starts by enabling the RUN/STEP or TEST MODE switches. The Run/Step or Test Mode switch sets the Go 1 FF on module V49, p. 19. The Go 2 FF (module V55) sets and starts the timing chain if the

Go 1 signal is present and the Display FF set. The Go 2 FF sets at time 25 and the timing chain starts 75 nsec later at time 00.

## RESTART TIMING CHAIN

There are three main gates for restarting the timing chain without using the manual switches. These are the conditions for restarting the computer during program control.

1) Stop 2 FF clear and Storage Resume signal present
2) $\mathrm{H} 07(\overline{\mathrm{MC}})[\overline{\mathrm{B} \mathrm{cycle}}+$ (IM.OP.) (ROP) $]$
3) H 05 and SC 2
or
or
4) Go 2 FF set

The first condition restarts the timing chain after a storage reference. The second condition restarts the timing chain at the end of the B cycle if no storage reference is initiated or at the end of the $A$ and $C$ cycles. The third condition occurs during the C cycle of a Shift instruction. The SC 2 signal blocks H06 and H07 and restarts the timing chain early.

## SET F REGISTER

Output pins 3 and 5 of module V55 enable the setting of the $F$ register under the following conditions:

1) $\overline{\text { Sweep + Enter }}$ (RNI) (Go 2)
2) $\overline{\text { Sweep + Enter }}$ (RNI) (Resume) (Stop 2)

The Run/Step or Test Mode switches enable the first condition and the storage resume enables the second condition.

## TIMING CHAIN AND CONTROL (Continued)



$$
\begin{gathered}
6.2 \\
\operatorname{Rev.} \mathrm{~A}
\end{gathered}
$$



There are five modes of operation in the 1700 which enable a general series of commands for groups of instructions.

| 1) | RNI $=$ Read Next Instruction |
| :--- | :--- | :--- |
| 2) | ADR $=$ Addressing |
| 3) | REG $=$ Register Transfer |
| 4) | ROP $=$ Read Operand from Storage |
| 5) | STO $=$ Store Operand in Storage |

## RNI

The command timing for all instructions starts in the RNI mode. During RNI, the instruction code transfers from the $Z$ register to the $X$ register and from the $X$ register to the $F$ register. While in the $F$ register, the instruction code is translated to determine whether it is addressable. If it is addressable, the ADR mode is initiated. If it is not addressable, the REG mode is initiated. A block diagram on the lower portion of the diagram shows the possible sequence paths.

The RNI Control FF is located on module V71 and has five main setting gates. If any one of the gates is satisfied, the RNI mode is enabled.

1) Master Clear - before starting a program.
2) (B150)(STO2) - after storing an operand
3) (B150) (ROP 2) $[\overline{\mathrm{RAO}}$ (ROP) $]$ - after reading an operand (except Replace Add One instruction)
4) (B150) (ADR) [(JMP) (End ADR)] - after addressing (Jump instruction only)
5) (B150) $[(\mathrm{REG})(\overline{\mathrm{SPB}+\mathrm{CPB}+\mathrm{EXI}+\mathrm{INT})}]$ - after REG mode (except Set/Clear Program Protect, Exit Interrupt, and interrupt during REG)

The RNI Control FF clears at time 150 of the $B$ cycle (B150) if none of the setting gates are satisfied.

ADR
Instructions which are read from or written into storage use the ADR mode. The only exceptions are Set/Clear Program Protect, Exit Interrupt, and Interrupt During REG mode in which the address is already determined. During the ADR mode, storage is always requested.

The ADR Control FF is located on module V70 and has one main setting gate which enables the ADR mode.
(RNI) (A050) ( $\mathrm{F} \neq 0$ ) $\quad[(\overline{\text { Protect Fault }})(\overline{\text { Sweep }+ \text { Enter }})]$ - after reading
next instruction, if $F \neq 0$, not addressing a protected instruction from an unprotected instruction and Sweep or Enter switch not enabled.

Storage is referenced when the Sweep switch is on but not during an ADR mode.

The ADR Control FF clears at time V300, providing the RNI, ROP, or STO Control FF is set. The setting of the two control FFs overlap but the mode remains ADR until the ADR FF clears.

## REG

Instructions which do not reference storage for reading or writing operands are considered as being in the Register Transfer mode (REG). During REG, computer control enables control FFs, enables register transfers, updates the address for the next instruction, and requests storage. The exceptions are Set/Clear Program Protect, and Exit Interrupt, where the REG mode is followed by an ROP mode. During the REG mode of these instructions the address is modified and storage requested. The address for the next instruction is updated during the ROP mode. If the computer is in REG mode when an interrupt occurs, the STO FF sets and enables STO mode.

The REG control FF is located on module V70 and has one main setting gate which enables the REG mode.
(Protect Fault) $+[($ RNI $)(A 050)([$ Sweep + Enter $]+F=0)]$
A Protect Fault signal enables the REG mode and treats the instruction as a nonprotected "Pass" with REG mode updating the address of the next instruction. The Sweep or Enter signal enables the REG mode during RNI, and the next address is updated without using ADR mode. If the upper 4 bits of the instruction equal zero ( $F=0$ ) the REG FF sets during the RNI mode.

The REG Control FF clears at time B300 whenever the set input is not satisfied.

## SEQUENCE CONTROLS (Cont'd)

ROP
The ROP mode applies to instructions which read operands from storage and the EXI, SPB, and CPB instructions.

The ROP Control FF (ROP 1)is located on module V64 and has two main setting gates. The ROP $2 \cdot \mathrm{FF}$ on module V71 provides a delay which prevents the RNI FF from setting at the same time (B150) as ROP or STO. The setting gates for ROP I are as follows

1) (B150) (ADR) [(End ADR $+\overline{\mathrm{STQ}+\mathrm{RTJ}+\mathrm{STA}+\mathrm{SPA}) \text { (End ADR) }) ~(E)}$ (JMP + End ADR)] - not a Store instruction, end of addressing, and not a Jump instruction. The End ADR condition is not considered in the setting of the FF.
2) $(\mathrm{B} 150)(\overline{\mathrm{INT}})[\mathrm{REG}(\mathrm{SPB}+\mathrm{CPB}+\mathrm{EXI})]$ - an interrupt during REG mode enables STO.

The ROP 1 FF clears at time B300 if the RNI or STO 1 FF is set. The normal sequence path is from ROP to RNI, as a Replace Add One instruction is necessary to set STO.

## STO

The STO mode applies to instructions which write operands into storage and interrupts occurring during the ADR or REG modes.

The STO Control FF (STO 1)is located on module V64 and has two main setting gates. The STO $2: F F$ on module V71 provides a delay which prevents the RNI FF from setting at the same time (B150) as ROP or STO. The setting gates for STO 1are as follows:

1) $(\mathrm{B} 150)(\mathrm{ADR}+\mathrm{REG}) \quad[(\mathrm{End} \mathrm{ADR})(\mathrm{STQ}+\mathrm{RTJ}+\mathrm{STA}+\mathrm{SPA})+\mathrm{INT}]$ interrupt enables STO 1 from ADR or REG mode, other instructions come from ADR mode only.
2) (B150) (ROP 2 (RAO) - Replace Add One instruction came from ROP mode. It reads from and then writes into storage

The STO 1 FF clears at time B300 if the RNI FF is set. The computer always initiates an RNI mode after writing into storage.


## CYCLE CONTROL

One pass down the timing chain is considered a cycle. The 1700 Computer has three unique cycles.
1)
2) $\quad \mathrm{B}$ cycle (storage request)
3) $\quad$ c cycle (iterative)

The normal cycle sequence is resume, request, resume, request, etc. or $A \rightarrow B \rightarrow A \rightarrow B$, etc.

The Multiply, Divide, and Shift instructions use a C cycle in addition to the A and $B$ cycles. The C cycle is iterative because the computer stays in the C cycle until shifting for that particular instruction is complete. The C cycle occurs between the resume and the next request.

$$
A \rightarrow C \rightarrow B
$$

A and B cycles are always 400 nsec long. C cycles are either 200, 300 (short cycle) or 400 nsec long. Shift C cycles are 200 nsec long and multiply C cycles are 300 nsec long until the last C cycle ( $\mathrm{Y} 00-04=0$ ), which is 400 nsec long. All C cycles for divide are 400 nsec long.

Cycle control, sequence control, and timing chain times are combined to enable specific conditions in command timing. For example, an instruction
may have two or more B cycles and time 100s. The sequence mode combined with B100 enables a unique condition such as ADR (B100), ROP (B100), or RNI (B100).

The three modules below contain two Control FFs and the fan-out for each cycle. The Early Cycle FFs set at time 350 and clear at the following 350 time. The Normal Cycle FFs set at time 00 and clear at the following time 00 providing the corresponding Early Cycle FF is set.

A Master Clear pulse starts the computer in the A cycle. At time A350 the Early B or Early C Cycle FF sets, depending upon the condition (ROP) (MUI + DVI) + Shift Cycle. At the same time the Early A FF clears. The A Cycle FF clears and the B or C Cycle FF sets 50 nsec later. B cycles are followed by A cycles either upon a storage resume or ( $\overline{\mathrm{ROP} \text { ) (IM.OP) condition. C cycles }}$ are followed by B cycles or another C cycle. The Multiply Step + Divide Step condition reinitiates the C cycle. The C Cycle FF does not need a reinitiation pulse for Shift instructions. During the shift cycle the Early C Cycle FF does not clear because the H06 pulse is not available. Short Cycle 2 (SC 2 blocks the setting of H06 and H07 during a shift cycle (see Timing Chain, page 7). The (H05) (SC 2 pulse (page 7 module V55) restarts the timing chain after each shift, and the computer remains in the cycle. On the last iteration of shift, the $\overline{\mathrm{SC} 2}$ pulse enables H06, and the Early C Cycle FF clears.


## ADDRESSING CONTROLS

The outputs of the four modules belaw are-addressingecanditions used in command timing. These addressing translations enable commands used in assembling the effective address. Module V63 contains three addressing control FFs.

## READ INDEX

The setting of the Read Index FF indicates that the present storage reference is for the Index register (address 00FF). The Read Index FF sets at time A300 when the following condition is present:

$$
\overline{\text { ind }}(\mathrm{i})(\overline{\mathrm{RNI}}+\Delta \neq 0)(\overline{\mathrm{NNT}})
$$

This condition does not mean that the Indirect and Relative signals are unused in forming the effective address. It means that these conditions are not available when indexing. Indexing is the last operation in forming the effective address.

The output of the Read Index FF is used in forming other addressing conditions. When the set condition is disabled, the Read Index FF clears at time A300.

## IMMEDIATE OPERAND (IM. OPb

The IM. OP. FF sets at time A300 when the indicated condition is present. The IM. OP. signal means that the effective address is the operand for Read Operand instructions. The three addressing modes which use IM. OP. are marked by an 6 at the bottom of the chart on page 115. The IM. OP. FF clears at the first A300 time after addressing is complete.
$\Delta=0$

The $\Delta=0$ FF sets at time A050 of the RNI mode when $\Delta=0$. This FF enables the $P+1$ portion of the effective address and is combined with other translations to form addressing conditions. This FF stays set until the next A050 time of RNI.


## MANUAL CONTROLS (REGISTER SELECTION AND CLEAR CONTROLS)

A six-position Register Selector switch and associated logic selects one of the $X, A, Q, P, y$, and Mask registers for manual display and entry.

The condition (Register Selector switch set) (Display) (T25) sets a FF in the V30 module that corresponds to the Register Selector switch position. (Since only one position of the Register Selector switch can be engaged at one time, two or more registers are not available simultaneously.)

The output from the set FF goes to the V41 module enabling an inverter if the condition (Display) (Clear) exists. Then the selected register is cleared. The following table shows the other conditions which cause a register to clear.

CONDITION
SPA (STO)(A cycle)(V250) ROP (A cycle)(V250)(MUI)
(Protect Fault)(RNI)(A cycle)(Sweep ${ }^{+}$ ENTER)(V 050)
Interrupt $\operatorname{STATE} \longrightarrow \mathrm{Y}$

CLEARS
entire A register entire $Q$ register
upper 8 bits of $X$ register upper 8 bits of $Y$ register

If the Master Clear switch is set, all six registers clear simultaneously.

notes

1. CAPACITOR VALUES ON V3O MODULE MAY BE O.1 $\mu \mathrm{F}$ ON
some machines. see change order no. 14392.

| CONTROL DATA CORPORATION | $\left.\right\|^{\text {TiTLE }}$ MANUAL CONTROLS |  | $\begin{aligned} & \text { Provect } \\ & 1704 \end{aligned}$ |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | (REGISTER SELECTION | AND | $\stackrel{1}{0 \times 2}$ | $\begin{aligned} & \text { onavinco } \\ & 601527 \end{aligned}$ |  |  |
| COMPUTER DIVISION | CLEAR CONTROLS) |  |  |  | ${ }^{\text {PaOE }} 15$ |  |

## MANUAL CONTROLS (SWITCH AND INDICATOR DRIVERS)

The Selective Skip, Program Protect, and Enter/Sweep switches connect to the V66 module. The Selective Skip switch is a 3-position lever switch that is OFF in the center position; ON in the up and down position. The up position is fixed and the down position is momentary. The Selective Skip switch in the ON position conditions the Selective Skip instruction shown on page 43. Placing the Program Protect switch in the up position, conditions the Program Protect logic shown on page 69.

The Enter/Sweep switch is a 3-position lever switch which is fixed in all positions with the center position OFF. In the
1 ENTER position, each step operation of the Run/Step switch stores the contents of the X register at the location specified by the $P$ register and advances the $P$ register by one. In the SWEEP
| position, each step operation of the Run/Step switch transfers the contents of the storage location whose address is in the P register into the $X$ register and advances the $P$ register by one, with the exception of the first step operation following a MC or Clear $P$ function.

1. Program Protect Fault - This indicator will be lit when a violation of the program protect system has been detected.
2. Storage Parity - This indicator will light anytime a parity error has been detected in data read from storage.
3. Overflow - This indicator will light when arithmetic overflow has occurred.
4. Program Protect - This indicator lights when the program protect bit of the last word read from storage is set.
5. Instruction - The instruction indicator will be illuminated anytime RNI is set.
6. Operand - The operand indicator will be turned on when the follow ing translation exists:
$\mathrm{STO}+\mathrm{ROP}+\mathrm{IM}$ OP
7. Indirect Address - This indicator will be on when the following translation exists:
$\overline{(\mathrm{Im} \mathrm{Op})}$ (Read Index) (ADR).
8. Storage Index - The index indicator will light anytime OOFF is referenced.
The 16 pushbuttons connected to the V66 and V67 modules control manual entry into a selected register. A set pushbutton ANDed with the Display condition sends a " 0 " to the Adder/Shifter. This puts a " 1 " into the corresponding bit position of the selected register. The indicators on the two V68 modules (locations A64 and B64) display the contents of the selected register (Display condition present). An enabled indicator represents " 1 " in that location.

When set, the Clear pushbutton attached to the V66 module clears the contents of the selected register. When a bit is manually set, it remains in that state until the Clear pushbutton is enabled.

A V68 module (location C64) controls the eight indicators (excluding TEMP) located on the left side of the 1700 console. Note that a " 0 " input enables the corresponding indicator.


The Test Mode switch connects to module V85. Modules V85 and V88 contain the Test Mode logic. The computer executes the following sequence of events when the Test Mode switch is placed in the down position:

1) 100 usec delay before Test Mode is operational.
2) 20 usec Master Clear. This clears the P register and all other operational registers.
3) 100 usec program run starting from $P=0000$.
4) Return to step 2 and repeat.

The accompanying timing chart shows the setting and clearing of the three Test Mode FFs. The Test Mode Go FF enables a 100 usec Go pulse to the Go1 FF on module V49. The Go1 FF sets the Go2 FF 75 nsec later. The Go2 pulse starts the timing chain which runs for 100 usec or until a Program Stop is enabled. At the end of 100 usec the Test Mode Clear FF enables the Master Clear and the timing chain stops.


MASTER CLEAR (MC)
The Master Clear switch connects to module V85. A Master Clear is executed when the switch is momentarily placed in the up or down position. The Master Clear disables the timing chain, clears all registers, and clears most Control FFs. Modules V85 and V06 contain Master Clear fan-outs.

Module V88 contains a delayed Master Clear for storage control. This allows the completion of the present storage reference and prevents unnecessary fault conditions from occurring.

## LOGIC VOLTAGE SENSOR

Module W00 is used to determine power failures by sensing the +6 -volt logic bus. When the voltage drops below a preset value, the special circuit de-energizes relay K4 and protects memory. Another output of module $W 00$ is used to generate interrupt 00 on power failure. Approximately 8 milliseconds of program execution time is available between relay coil de-energization and contact closure.

The logic voltage sensor can be disabled for voltage margin checking by turning the MARGIN MODE switch on (this switch is located on the memory power supply).


## TYPICAL REGISTER DISPLAY

The diagram below shows a typical register display sequence using the A register. For a starting reference, assume the following conditions:

1) Power on
2) A register selector button pressed
3) Timing chain stopped
4) Display FF set (enabling pushbuttons and display)

When the Run/Step switch is momentarily placed in the up position (RUN), the timing chain starts and the switches and display are disabled. The following timing chart shows the setting and clearing of Control FFs for starting the computer.


The timing chain is disabled and the display enabled when the Stop FFs set. The timing chain can not be restarted until the Run/Step switch is activated. The
individual bits of the A registers are manually set by the bit pushbuttons while the Display FF is set. Pressing a bit pushbutton enables the Adder/Shifter to set the corresponding bit in the A register and light the corresponding bit indicator. The raw clock pulses enable the setting of the A register, although the timing chain is stopped. The following timing chart shows the setting of Control FFs for stopping the computer.


Pressing the Clear pushbutton clears the A register if the Display FF is set. Other registers may be selected while the Display FF is set by pressing the corresponding register selector switch. For example, if the $X$ register is selected, the Adder/Shifter samples the X register and the corresponding bit indicators light.

## TYPICAL REGISTER DISPLAY (Cont'd)

The computer is stopped momentarily by placing the Run/Step switch in the down position. If the switch is repeatedly placed in the down position, the computer steps through the program, stopping after each storage ref erence. The significance of the storage reference just made is indicated by the instruction sequence indicators.

This diagram shows a typical register display sequence (A register). The register selector switch must be set for the A register. With the Run-Step switch (page 19)
in the center position, the Neutral FF is set. When the switch is placed in the STEP position, the timing chain stops at the end of the current storage reference and the display is enabled. During the step sequence, the Go 2 FF remains cleared and the Stop 2 FF sets, thus disabling the timing chain at the end of the B cycle. The Display FF sets when Stop 2 is set and a Resume and 75 time are present. Each step pulse sets Go 1, Go 2, and moves the timing chain one storage reference. The chain is stopped by the 125 pulse clearing Go 2 before the next storage reference.


## F REGISTER

The 8-stage F register is divided into two 4 -stage groups contained on two
V57 modules. The low-order four stages (F8-F11) contain the $\mathrm{f}^{1}$ instruction den designator bits. The stages of the $F$ register are numbered $8-15$ to coincide with the instruction bit positions that they contain. The outputs of the F register translate into the various function codes.

In storage reference instructions, the low-order stages of the $F$ register contain the relative ( $r$ ), indirect (ind), $Q$ register index ( $q$ ), and storage index ( $\mathbf{i}$ ) designators as shown on the diagram. In this type of instruction, the designators control the addressing mode of instruction execution.

## $\mathrm{X} \rightarrow \mathrm{F}$ CONTROL

At t25 time of each RNI sequence, inverter A forces a " 0 " input to $B$ on the V 57 modules. The outputs of $A$ and $B$ transfer the high-order eight bits in $X$ to $F$. Thus, the $f$ and $f^{1}$ designator portions of the instruction are transferred at this time.

## F REGISTER CLEAR CONTROL

The diagram shows the conditions under which both the $f$ and $f^{1}$ positions are cleared. The enabling of one of these conditions, e.g., Protect Fault, produces "0" outputs from inverters $E$ and $F$ on the V56 module. The resulting "1" outputs from the output inverters on this module clear the $F$ register.

During the ADR mode of storage reference instructions, the $r$, ind, $q$, and designators in the $f^{1}$ portion are cleared individually. The following table
lists the conditions for clearing each of the designators.

| Designator | Conditions | Time |
| :---: | :---: | :---: |
| r (F11) | (ADR) (B cycle) (Disable Clr r) | V300 |
| ind (F10) | (ADR) (A cycle) (X15) ( $\overline{\mathrm{RNI}}$ ) ( $\overline{\mathrm{F} 11}$ ) | V100 |
| q (F9) | (ADR) ( $\overline{\mathrm{INT}}$ ) ( $\overline{\mathrm{ind}}$ ) (q) ( $\overline{\mathrm{RNI}}+\Delta \neq 0$ ) ( B cycle ) | V100 |
| i (F8) | (Read Index) (B cycle) | V300 |

(F8)
(Read Index) (B cycle)
V 300
Timing pulse V300 clears the r designator during the B cycle of the ADR mode if condition (Disable Clr $r$ ) is present. At this time, all relative addressing is complete. If $r$ was not initially set, the operation becomes irrelevant.

The above table shows that the clearing of ind during the A cycle of ADR following the reading of the indirect address ( $\overline{\mathrm{RNI}}$ ) ( F 11 ) depends on the state of bit 15 contained in the X register. If this bit is a " 1 " indicating that the addres corresponds to another indirect address, V100 does not clear ind. If this bit is a " 0 ", indirect addressing is complete and ind is cleared.

The V 100 pulse clears q during the ADR mode on a INT condition. If indirect r relative or both Addressing modes were initially specified, these operations are completed first. The condition for clearing q specifies that q must be initially set.
The V 300 pulse clears i during the $B$ cycle on a Read Index operation. The condition for clearing i need not specify the ADR mode since a Read Index can occur only during this mode. The adding of the index always takes place las if any other addressing mode designators were initially set.


## FUNCTION TRANSLATORS

The Function Translators translate the contents of the F register to obtain the current instruction. The 1700 repertoire of instructions may be grouped into Storage Reference instructions (F portion) and Register Reference instructions ( $\mathrm{F}^{1}$ portion). In the table of instructions on page 26, the Storage Reference instructions are in column one (beginning with JMP) and the Register Reference instructions are in column three (beginning with SLS).

Register Reference instructions are identified when the upper 4 bits (15-12) of the instruction are all " 0 's". The format of Register Reference is diagrammed below:


Storage Reference instructions have their instruction code in bits 15-12, and bits 11-08 become the address mode. Storage Reference instruction format is diagrammed below:


INSTRUCTION

The static logic of the Function Translator translates the 16 -bit input to the selected instruction. The logic searches through the input until it recognizes a unique instruction. The Function Translator dispenses the signals that enable the selected instruction and its associated logic.


FUNCTION TRANSLATIONS

| ADDRESSABLE |  |  |  |  |  | REGISTER REFERENCE |  |  | INTER-REGISTER |  |  | SKIPS |  | SHIFTS |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | F |  | -1-3 |  | $\mathrm{F}_{1}$ | $\square$ | $F_{1}$ |  | \% 76543210 |  | 2 |  | $\mathrm{F}_{2}$ |  |  |
|  | 0001 | JMP | Jump |  | 0 | 0000 | SLS | Selective Stop | 0000 / 0000 |  | 0000 | SAZ | $\mathrm{A}=+0$ | 00001111 |  |
|  | 0010 | MEI | Multiply |  | 1 | 0001 |  | SKIPS | Locical prod lp ${ }^{4}$ |  | 0001 | SAN | A |  | $\uparrow$ |
| 4 | 0011 0100 | DVI STO | Divide Store 0 |  | 2 | 0010 | INP OUT | Input to A | LOGICAL PROD |  | 0010 0011 | SAP | $A=+$ $A=-$ | T |  |
|  | 0101 | RTJ | Ret. Jump |  | 4 | 0100 | EIN | Output from A | ORIGIN REGISTERS |  | 0100 | Sq2 | Q $=+0$ | HFT A |  |
|  | 0110 | STA | Store A |  | 5 | 0101 | IIN | Inhibit Int. | destination recisters |  | 0101 | SQN | $Q \neq-0$ | Shift Q |  |
|  | 0111 | SPA | STA, Parity | A | 6 | 0110 | SPB | Set Prgm. Pro. |  |  | 0110 |  | $Q=+$ | IFT COUNT |  |
| 8 | 1000 | ${ }_{\text {AdD }}$ | Add to $A$ |  | 7 | 0111 | CPB | $\mathrm{ClF}_{\text {clic }}$ Prgm. Pro. | ORIGIN REGISTERS |  | 0111 1000 | SWM | $\mathrm{Q}=-$ |  |  |
| A | 1010 | AND | AND with $A$ |  | ${ }_{9}^{8}$ | 1001 | INA | IRTS ${ }_{\text {Increase }}$ A | If $\mathbf{A}(\mathrm{B}+5)=0$; OP1 $=$ FFFF |  | 1001 | SWN | Skip SW. |  |  |
|  | 1011 | EOR | Exc. OR/A |  | A | 1010 | Ena | Enter A | If Bits 3+4 $=0$; OP2 $=$ FFFF |  | - 1010 | sov | Overflow |  |  |
| c | 1100 | IDA | Load A |  | B | 1011 |  | NO-OP | If Bits $3+4=1 ; 0 P 2=(Q)+(M)$ |  | 1011 | SNO | Overflow |  |  |
| D | 1101 | RAQ | Replace Add 1 |  | c | 1100 | ENQ | Enter Q |  |  | 1100 | SPE | Parity Error |  |  |
|  | 1111 | LDD | Load $Q$ Add to $Q$ |  | D | 1101 | INQ | Increase Q | $\underset{\text { Both }}{\mathrm{LP}+\mathrm{XR}} \mathbf{0}$; Sum of OP1 $+\mathrm{OP2}$ |  | 1101 | SNP | Parity Error |  |  |
|  | 1111 | ADQ | Add to Q |  | F | $\begin{aligned} & 1110 \\ & 1111 \end{aligned}$ | EXI | Exit Int. Shifts | Both $=0 ;$ Sum of OP1 + OP2 Both $=1 ;$ Complement of LP |  | $\begin{array}{ll} 1110 \\ 8 & 1111 \end{array}$ | $\begin{aligned} & \text { SPP } \\ & \text { SNP } \end{aligned}$ | $\begin{aligned} & \text { Prgm. Pro. Fault } \\ & \text { Prgm. Pro. Fault } \end{aligned}$ |  |  |





| E CONTROL DATA | TRANSLATIONS | ${ }^{\text {moousf }} 1$ |
| :---: | :---: | :---: |
|  |  | (1) |
| COMPuter division |  |  |

## A REGISTER

The 16-stage A register functions as the Main Arithmetic register. The main functions of the A register are:

1) To contain one operand during many Arithmetic and Logical operations, such as ADD, SUB, AND, etc.
2) To provide a means of loading operands into the arithmetic section (LDA) and of storing the results of Arithmetic or Logical operations in storage (STA, SPA).
3) during multiplication operations, to initially contain the multiplier. At the completion of the multiply, the A register contains the low-order 16 bits of the 32 -bit product.
4) during divide operations, to initially contain the low-order 16 bits of the dividend, and at the completion of the divide, to contain the quotient.
5) in input or output operations, to contain the input or output data respectively.

The A register is divided into two 8-stage portions contained on two V01 modules. The outputs of the A register transfer to the Adder/Shifter through the A fan-out modules. The A register receives inputs from the Adder/Shifter fan-out, the input receiver modules in the $A / Q$ interface, or the receiver modules in the is controlled by the Adder $\rightarrow$ A and Input $\rightarrow$ A FFs on the V40 module .

ADDER $\rightarrow$ A
The Adder $\rightarrow$ A FF selects the Adder/Shifter input to the A register. The diagram shows that this FF is set at one of three V-50 timing periods by the enabling of the corresponding conditions. The setting of the Adder $\rightarrow$ A FF forces a " 0 " input to inverters A and B on the V15 and to inverter A on the V16 fan-in modules. The " 1 " outputs of these inverters enable the Adder/Shifter outputs to the corresponding inverters on the V15 and V16 modules. The following to0 pulse gates the outputs of the fan-in modules into the A register. Thus, the Adder $\rightarrow$ A FF is set on the $t 50$ time preceeding the to pulse that loads the A register, allowing 50 nsec for the inputs to stabilize. The t25 pulse always clears the Adder $\rightarrow$ A FF. The $A \rightarrow$ Adder pulse also sets the
Adder $\rightarrow$ A FF on a manual selection of the A register.

The A register receives an input from the Adder/Shifter in four main types of instruction operations. Each of the four types is given below with a brief description of the conditions for each type.

Shift
In (A) Shift instructions, the Adder $\rightarrow$ A FF is set at two unique times. The V050 pulse sets Adder $\rightarrow \mathrm{A}$ in each C cycle with the $\mathrm{A} \rightarrow$ Adder enable through inverter $F$. The V250 pulse also sets Adder $\rightarrow A$ in the $C$ cycle under the same conditions. Thus, Adder $\rightarrow A$ is set twice ( $A$ shifted twice) during each $C$ cycle if $Y$ (shift count) is not found to be " 0 " before each shift.

During short cycle (SC1) operations in Multiply and Shift instructions, the V2 50 pulse occurs 100 nsec earlier, corresponding to the short cycle of the operand transmission through the adder/shifter.

In (AQ) shifts, Adder $\rightarrow A$ is set only at V250 time since the $A \rightarrow$ Adder signal is not present at the V050 time.

Multiply Divide
In Multiply or Divide operations, Adder $\rightarrow A$ is set during the $B$ and $C$ cycles in the ROP mode. The setting of Adder $\rightarrow A$ on the $B$ cycle at 250 time transfers the complemented A (A initially negative) or the uncomplimented V150 pulse sets Adder $\rightarrow$ the product to the A register. In Divide Step operations, the setting of Adder $\rightarrow$ A at this time transfers the shifted partial dividend back to the A register.

## $I R+E N A+I N A$

The Adder $\rightarrow$ A FF is set on V250 time of the A cycle in the REG mode in the Enter A (ENA) and Increase A (INA) instructions. In either of these instructions, the new quantity is transferred to A at this time. In IR instructions, the setting of $X 2$ selects the $A$ register as the destination register. In this case, the V250 pulse sets the Adder $\rightarrow$ A FF in the A cycle.
$\mathrm{LDA}+\mathrm{ADD}+\mathrm{AND}+\mathrm{EOR}+\mathrm{SUB}$
In these instructions, the V250 pulse sets Adder $\rightarrow$ A during the $B$ cycle which enables the transfer of the arithmetic or logical result to the A register.

SPA
The V250 pulse sets Adder $\rightarrow$ A in the SPA instruction during the A cycle of the STO mode if the parity bit of the word being written in storage is a " 1 "
(parity even). The setting of Adder $\rightarrow$ A at this time enables the transfer of (parity even). The setting of Adder $\rightarrow A$ at this time enables the transfer of a +1 to the A register.

INPUT $\rightarrow$ A
The Input $\rightarrow$ A FF enables the transfer of the output of the input receivers in the A/Q or low-speed interface to the A register through the fan-in modules. setting of Input $\rightarrow$ A in Character mode forces " 1 " outputs from the output inverters C and D on the V15 modules and inverter B on the V16 modules. Th modules. The to0 pulse transfers the 16 -bit data word to the A register.

In the Character mode, the " 0 " input to the * inverter disables the input transfer to the high-order eight stages of the A register. The 8-bit character transfers to the low-order eight stages of the A register at t00.

The V250 pulse sets the Input $\rightarrow$ A FF during the A cycle of the INP instruction if the selected input device sends no Reject signal.


Q REGISTER

The 16 -bit Q register (auxiliary arithmetic) assists the A register in performing arithmetic and logical operations. The Q register is also used as an Index register for storage reference instructions and as an Output Address register for nonbuffered I/O.

The $Q$ register is divided into two V01 modules and receives its inputs from four V06 Adder/Shifter fan-out modules. The outputs of the $Q$ register return to the Adder/Shifter via the A, Q fan-out modules and addend gates.

The Adder $\rightarrow$ Q FF controls the input to $Q$ register selection.
ADDER $\rightarrow \mathrm{Q}$ CONTROL
The Adder $\rightarrow$ Q FF has three main setting gates. The first is satisfied if the manual
$Q$ register selector on the console is activated and the $Q \rightarrow$ Adder FF is set.
At time V0.50 of the $C$ cycle, the second gate is enabled if one of the indicated
conditions is satisfied. At time V250, the third gate is enabled if one
of the indicated conditions is satisfied. The t25 pulse clears the Adder $\rightarrow$ Q FF in all cases.

The setting of the Adder $\rightarrow$ Q FF enables a pulse to the $A$ and $C$ inverters of the V01 modules at t00. Therefore, the transfer from the Adder/Shifter to the $Q$ register occurs 50 nanoseconds after the Adder $\rightarrow \mathrm{Q} \mathrm{FF}$ is set.

If the condition $\overline{\mathrm{H} 01 \text { (Div. Step)(EAB) }}$ is not satisfied, inverter* has a " 1 " output and the transfer of data to the Q register is blocked, even though the Adder $\rightarrow$ Q FF is set. This condition may occur during a divide step when subtracting (X) from (Q). An EAB occurs when $X>Q$.
The $Q$ register clears when either the manual clear or Master Clear is selected. The inverters on V41 send a pulse to inverters $E$ and $F$ on the two V01 modules, clearing all Q register FFs.


## A, Q FAN-OUT

The A, Q FANOUT provides three additional outputs for the A and Q register.

The Adder/Shifter Fan-In, AQ I/O, and Skip FF receive the contents of the A, Q FANOUT. The * inverters in each Module send several bits in
a group to the Skip FF. If the group of bits in " 0 ", the output of the * inverter is a " 0 ", which is inverted and sent to the Skip FF. The Skip FF searches for Zero contents of the A or Q registers.


## P REGISTER

The P register contains the address of the current instruction. In most cases the $P$ register advances by one near the completion of each instruction. The outputs of the $P$ register enter the addend gates of the Adder/Shifter. The
Adder/Shifter forms the next instruction address, returning it to the $P$ register.
The $P$ register consists of 15 stages divided into two V01 modules. The $P$ register receives inputs from four V06 Adder//Shifter fan-out modules. The V06 modules provide the input gates which select the Adder/Shifter inputs.
The Adder $\rightarrow \mathrm{P}$ FF controls the input to P register selection.
ADDER $\rightarrow \mathrm{P}$ CONTROL
The Adder $\rightarrow$ P FF has three main setting gates. The first gate is satisfied if the manual $P$ register selector on the console is activated and the $P \rightarrow$ Adder

FF is set. At time V050 of the B cycle, the second gate is enabled if one of the indicated conditions is satisfied. At time $\mathbf{V} 250$, the third gat is enabled if one of the indicated conditions is satisfied. The t25 pulse clears the Adder $\rightarrow \mathrm{P}$ FF in all cases.
The setting of the Adder $\rightarrow$ P FF enables a pulse to the $A$ and $C$ inverters of the V01 modules at t00 Therefore, the transfer from the Adder/Shifter to the $P$ register occurs 50 nanoseconds after the Adder $\rightarrow P$ FF is set.
The $P$ register clears when either the manual clear or Master Clear is selected. The inverters on V41 send a pulse to inverters $E$ and $F$ on the two V01 modules, clearing all P register FFs.


The X register consists of 16 stages divided into two V01 modules. The X register receives inputs from the $Z$ register and the Adder/Shifter through the two V19 fan-in modules. The V19 modules provide the input gates which select the $Z$ register or Adder/Shifter inputs.

The Resume and Adder $\rightarrow$ X FFs control the input to $X$ register selection. The Resume and Adder $\rightarrow \mathrm{X}$ control FFs are described below.

## $Z \rightarrow X$ CONTROL (RESUME)

The Storage Resume signal sets the Resume FF at time $t 50$ and clears the Req. Mem. FF解 transfer occurs only on Storage Read operations.

The outputs pass through inverters $G$ and $H$ and apply " 1 " inputs to $A$ and $C$ in the 01 modules. Additional Resume outputs enter C and D in the fan-in (V19) modules. As a result, the $Z$ register " 1 bits enter the $X$ register at time to0. The $X$ register stages corresponding to "0's" are cleared.

The t25 pulse clears the Resume FF. Thus, this FF remains enabled for 75 nsec after it is set

## ADDER $\rightarrow \mathrm{X}$ CONTROL

The Adder $\rightarrow$ X FF has four main setting gates. The first of these sets the Adder $\rightarrow$ X FF during a B cycle at time V050 if one of the indicated conditions is satisfied. The remaining three main gates set the Adder $\rightarrow X$ FF at time V250 if the necessary conditions are satisfied. The $X \rightarrow$ Adder enable also sets the FF in a manual selection. The t 25 pulse clears the Adder $\rightarrow \mathrm{X}$ FF in all cases

The setting of the Adder $\rightarrow$ X FF enables the Adder/Shifter input to the $X$ register through inverters A and B on each V19 module. Thus, the t00 pulse transfers the Adder/Shifter output to the $X$ register.

## X REGISTER FAN-OUT

The $X$ register output passes through four fan-out modules to obtain additiona outputs and for control functions such as the extending of the $\Delta$ sign bit.
The low-order five stages of the X register pass through the V26 module. Each of the low-order four of these stages has four outputs that go to destinations ranslation is also sensed on this module for the low-order five stages

Stages 5, 6, and 7 pass through the V2 7 module. These stages each have six outputs as indicated.

The high-order eight stages of the X register pass through two $V 28$ modules These stages have four outputs as shown except the sign bit (stage 15) and stage 11. The extra outputs of stage 11 are not used. The $V 28$ modules also sense for the $\mathrm{F} \neq 0$ condition of the corresponding bits.

## SKIP TRANSFERS

In the execution of a Skip instruction, the low-order four bits of the instruction, and thus the X register, contain the skip count. The outputs from stages ction forces " 0 "outputs of stages $04-07$ to the Addend gates and the Augend gates

## EXTEND SIGN

In the type of operations indicated, the sign bit of $\Delta$ (stage 07) is extended in the high-order eight outputs. If one of the indicated conditions is enabled and bit 07 is a " 1 " (negative sign), the output of the sign extension inverters on the V27 module enter inverters A and B on the two V28 modules. The outputs of $A$ and $B$ force " 0 " inputs to the fan-out inverters that feed the Addend and Augend gates. Thus, the high-order eight outputs to these gates are all "1's".
If, in a sign extension operation stage 07 contains a ' 0 " (positive), inverter A on the V27 module forces " 0 " outputs from the sign extension inverters. The resulting outputs of $A$ and $B$ on the V28 modules gate the outputs of the highorder eight stages of the $X$ register, which are cleared, at V050 time of each RNI sequence to the augend and addend gates.

ADSMR FAON N


The 16 -bit Y register is contained on two V01 modules. The Y register contains The 16 -bit Y register is contained on two $V 01$ modules. The Y register contain storage addresses for subsequent transfer during a storage reference. The
register is also used as a counter during Multiply, Divide, and Shift instructions.

The first V01 module contains bits $00-06$ and bit 08 . The second V01 module contains bit 07 and bits $09-15$. Bits $00-05$ and bit 08 receive inputs from a V22 module, and bit 06 receives its input from a V42 module. The seco
module receives its inputs from the V06 Adder/Shifterfan-out modules.

The control. FFs for the $Y$ register are contained on the $V 42$ module and receive set inputs from the V43 module. The Y register outputs feed V13 and V14 fanout modules and are gated to the $S$ register, Adder/shifter or $Y$ decrementer All control FFs set at 550 and clear at t25. The Y register gating occurs at t00. Therefore, the actual transfer to the Y register occurs 50 nsec after the control FFs are set.
The Y register clears when either the manual clear or Master Clear is selected The clear pulse enters inverters $E$ and $F$ on the two V01 modules, clearing all Y register FFs.

## ADDER $\rightarrow$ Y CONTROL

The Adder $\rightarrow$ Y FF has three main setting gates. The first gate is satisfied if the manual Y register selector on the console is activated and Y $\rightarrow$ Adder FF is set. At time V050 (V42) of the B cycle (V43), the second gate is set if one of the indicated conditions is satisfied. The third gate is set at time V250 (V42) of the A cycle (V43) if one of the indicated conditions is satisfied. The setting of the second V01 module. The V22 module provides the Adder/Shifter input gates for selecting bits 00-05 and bit 08 of the Y register. Module V 42 provides the input selection br bit 06 The second V01 module receives its inputs from the V06 Adder/Shifter fan-out modules.

For Shift instructions, the Adder $\rightarrow$ Y FF enables the lower 8 bits of the shif instruction format into the Y register. Bits 00-04 contain the shift count.

For other instructions, the Adder $\rightarrow$ Y FF enables the effective address or partially modified address into the Y register. The effective address is held in the $Y$ register until transfer to the $S$ register during a storage reference. Bit 15 does not transfer to the S register. Bit 15 is a sign bit when the effective address is an operand for Read Operand instructions.

## DECREMENT Y CONTROL

The Decrement Y FF has three main setting gates. If any one of the following gates are satisfied, the Decrement Y FF sets and the value in the lower 5 bits gates are satisfied, the Decrement
of the $Y$ register decreases by one.

| Time (V42) | Cycle (V43) | Condition |
| :---: | :---: | :---: |
| V050 | C | (Y00-04 $\ddagger 0$ ) (REG)(SHIFT)(QA SHIFT) |
| V250 | C | (Y00-04 $\ddagger 0$ ) |
| V250 V350 | $\begin{gathered} \text { or } \\ \mathrm{A} \end{gathered}$ | (Y00-04 $\neq 0$ ) (ROP) (MUI) (Y00-04 $\neq 0$ ) (REG)(SHIFT) |

The Decrement Y FF enables the $C$ inverter on the V22 module, and the A and C inverters on the first V01 module. This gates the decremented value to express the maximum shift count of $31=37=1 \mathrm{E}$. Five bits are needed for the multiply and divide when the $Y$ register 16 . $10_{16}\left(20_{8}=16_{10}\right)$ to 0 .


In short cycle (SC1) operations which occur only in shift or MUI instructions, the V250 pulse occurs 100 nsec earlier. This case effects only condition 2 listed previously. In this condition, the Decrement Y FF is set 100 nsec earlier since the short cycle requires 100 nsepc to transmit the operand through the Adder/Shifter.
$10{ }_{16} \rightarrow$ Y CONTROL
The ${ }^{10}{ }_{10} \rightarrow$ Y FF establishes the starting Y register count ( $10 \underset{\text { and }}{16}$ ) for Multiply and Divide instructions. As each shift and compare sequence ${ }^{16}$ is done, the Y register decrements by one until Y00-04 $=0$.

The $10{ }_{16} \rightarrow$ Y FF sets at time V050 (V42) of the A cycle (V43) when ROP and MUI $+{ }^{16}$ DVI signals are present. The $10 \rightarrow$ Y FF enables bit 04 of the $Y$ register to set at time 00 , thus forming a ${ }^{16}$ binary $10000\left(10{ }_{16}\right)$.

STATE $\rightarrow$ Y CONTROL
The State $\rightarrow$ Y FF enables the forming of an address to locate the return addresses for each of the 16 possible interrupt states. The table on page
70 shows the interrupt states and location of return addresses. The location of the return addresses may be formed by changing bits $02,03,04$, and 05 and setting bit 08 to a " 1 ".

Y REGISTER


The State $\rightarrow$ Y FF sets at time V050 (V42) of the B cycle (V43) when an Interrupt signal is present. The State $\rightarrow$ Y FF enables inverter $D$ on the V22 module and inverters $A$ and $C$ on the first V01 module. Four interrupt

## Y REGISTER (Cont'd)

state inputs are gated into the V22 module from the V11 and V12 module on page 71. At t00, the state inputs are gated into bits $02,03,04$, and 05 of address transfers through the V13 and $\dot{V} 14$ modules to the S register.

## CONSOLE INDICATOR CONTROL

Module V43 contains the control for three console indicators. The three indicator outputs are enabled by a display pulse on module V55, page 21. The display pulse enables the indicators only if the following conditions are present:

1) Indirect Address = (IM. OP.) (READ INDEX) ADR
2) Storage Index = READ INDEX
3) Operand $=\mathrm{STO}+\mathrm{ROP}+\mathrm{IM} . \mathrm{OP}$.

## (IM. OP. (ROP) CONTROL

An inverter whose output is (IM. OP.) (ROP) is located on the bottom of module V43. This pulse feeds module V55, page 7, and is one of the conditions which stops the timing chain.


## Y-DECREMENTER

The Y-Decrementer operates as a counter during Multiply, Divide, and Shift instructions. The lower 5 bits of the Y register hold the shift count which . decreases by one on each pass through the decrementer. The decrementing is performed logically by inspecting each bit in order, starting with Y00. Each bit is complemented until the decrementer reaches a " 1 ". The " 1 " is complemented and the remaining higher bits (if any) are transferred through the decrementer without being changed. For example, if Y00 is a " 1 " it is complemented, but Y01-04 remain unchanged during this particular pass.

When the count is reduced to zero ( $\mathrm{Y} 00-04=0$ ), the gate in the lower-right corner of the V08 module is enabled, the Y-Decrementer is disabled, and the shifting in the current instruction is completed.

## SKIP FF

A zero is the instruction field and a one in the sub-instruction field identifies a Skip instruction. Diagrammed below is the Skip instruction format.


When the skip condition is met, the contents of the skip count +1 is added to P to obtain the address of the next instruction (e.g., when the skip count is zero, go to $P+1$ ). When the skip condition is not met, the address of the next instruction is $\mathrm{P}+1$ (skip count ignored). The skip count does not have a sign bit.

The Z81 and V53 modules examine X04-07 to determine which skip instruction is to be executed. The table following illustrates the possible skip instruction translations and their conditions.

The Skip instruction conditions (contents of A and Q registers Selective Skip switch, Overflow, Storage Parity Error, and Program Protect Fault) enter the $Z 81$ module. The contents of the $A$ and $Q$ registers are sensed for sign and for zero or not zero.

| Skip Instruction <br> (Hex.) | Bits |  | Skip If |  |
| :---: | :---: | :---: | :---: | :---: |
|  | 7 | 6 | 5 |  |$|$| 4 |
| :--- |
| 0 |

The logic in the Z 81 and V53 modules recognizes the selected Skip instruction and determines if its conditions are satisfied. The conditions (V150) (REG) (SKIP) and the Skip instruction satisfied enable the Skip FF. The setting of the Skip FF sends a " 1 " through two inverters to the Adder $\rightarrow$ P FF shown on page 37

The condition (REG) (INP + OUT) (Reject) sends a " 1 " through two inverters to the same Adder $\rightarrow$ P FF as the Skip FF.

The condition (INP) (REG) ( $\overline{\text { Reject }})$ sets the I/O $\rightarrow \mathrm{A}$ FF shown on page 31.



The Exclusive OR (XR) and Logical Product (LP) control FFs enable the corresponding logical operations on the Adder/Shifter modules. The XR and LP FFs are contained on the V38 module. The inputs to the corresponding inverters | on the Z93 module specify the conditions for setting and clearing XR and LP.

## EXCLUSIVE OR (XR) CONTROL

When set, the XR FF enables the Exclusive OR (A $\forall B$ ) function in the Adder/ Shifter. The Exclusive OR can take place between two operands, as in an IR instruction, or between an operand and all " 1 ' $s$ ", as in complementing a negative operand in the Multiply instruction. Examples of both cases are shown below:


In both examples, a " 1 " appears in the result only when a " 1 " is in a certain bit position of one operand and a " 0 " in the same bit position of the other operand. Thus, a " 1 " results when a " 1 " exists in operand A or B but not in both. In the second example, all "1's" are used as a mask to complement operand A. In this way, a number can be converted to the ones-complement equivalent. The second example shows a negative number (operand A) converted to its positive equivalent through the XR function.

- The XR FF has two Set/Clear gates (A, B and C, D) and one set gate (E). The A, B gate sets XR at V100 time while the C, D input sets the FF at V300 time if one of the corresponding inverter inputs is satisfied on the $Z 93$ module. Inverter
- E. Metg XR at V200 time if the input to the corresponding inverter on the Z93 module is satisfied: (MUI) (SR1) (C CYCLE) + (DVI) (Y00-04 = 0) (SR 2) (C CYCLE).

A typical XR operation for the first example is had by assuming an IR instruction in the REG mode, A cycle enabled and bit $X_{6}$ of the instruction code set. The
setting of $X_{6}$ specifies an $X R$ operation between the operands in the origin registers ( $X_{3}, X_{4}$, and $X_{5}$ ). In this case, $X R$ is set at V100 time (A, B) and the Exclusive OR function is enabled in the Adder/Shifter modules. When the selected operands are gated into the Adder/Shifter, the Exclusive OR operation takes place.

An XR operation for the second example takes place during the A cycle of the ROP mode for a DVI instruction with SR 2 set. In this case, the initial dividend is negative (SR 2 set) and (Q) is complemented prior to the first divide step. Thus, XR is set at V300 time (C, D). Since (Q) is now gated to the addend gates while all " 1 's" are enabled into the augend gates, the XR enable complements the (Q) in the Adder/Shifter.

## LOGICAL PRODUCT (LP)

The setting of the LP FF enables the Logical Product (AND) function on the Adder/Shifter modules. The LP function takes place between two operands, as in IR or AND instructions, or between an operand and all "1's" to enable a straight-through transfer of an operand through the Adder/Shifter, as in a Multiply instruction. Examples of both cases are shown below:


In both examples, a " 1 " appears in the result only when a " 1 " exists in corresponding bit positions of the two operands. Thus, a " 1 " results when a " 1 " exists in operand A and B.

The LP function is often used to mask out certain portions of an operand, as in the first example. In this case the low-order 12 bits of operand $B$ are all " 0 's", and the high-order 4 bits are all " 1 's'. Thus, all but the high-order 4 bits of operand A are masked out.

For example, assume an AND instruction in the ROP mode, B cycle, and V100 time (H01) (t00). In this case, the operand read from storage (X) and the operand in A transfer to the Adder/Shifter simultaneously with the setting of LP. As a result, LP enables a Logical Product operation in the Adder/Shifter between the two operands.

The LP function also enables a straight-through transfer of an operand through the Adder/thifter. In this case, all the bits of one operand are "1's". Thus, operand A transfers through the Adder/Shifter either unchanged or shifted right or left.

An example of this type of LP operation is had by assuming a Multiply instruction, C cycle, and V100 time ( H 01 and t00). These conditions set LP simultaneously with the transfer of $(A) \rightarrow$ Adder. Since the Shift-Right control was previously set, LP enables the (A) to be shifted one place to the right.

The LP FF has two Set gates and two Clear gates. The Stopped mode sets LP through inverter $H$. The setting of LP at this time enables the transfer of the manually selected register output through the Adder/Shifter.

The other Set gate is enabled at to0 time if the input conditions to one of the - corresponding inverters on the Z93 module are satisfied. Three of the inverter gates are enabled at V100 time (H01 and t00) while the remaining gate is enabled at V300 time (H05 and t00).

The output of inverter E clears LP at V200 time (H03 and t00) simultaneously with setting XR. Inverter E is enabled at the termination of the C cycle of a Multiply or Divide instruction. The other Clear gate to LP is enabled at V300 time (H05 and t 00 ) if the input conditions to one of the corresponding inverters
\| on the Z93 module are enabled. For example, LP is cleared during the B cycle of each ROP mode at V300 time.



The Shift Adder Controls enable the left or right Shift operations on the Adder/ Shifter modules. These controls consist mainly of the Right Shift (RS) and Left Shift (LS) FFs, the Set/Clear input conditions, and the fan-outs for these FFs.

The RS and LS FFs and the input Set/Clear enables are contained on the V37 module. The RS, LS, and $\overline{\text { shift }}$ fan-outs to the Adder/Shifter modules are contained on the V23 module.

The RS and LS FFs are set and cleared under similar conditions. In Shift cycle operations, RS or LS is set by inverter F at V325 time ( t 25 and H06) in the A cycle. If bit $7\left(X_{7}\right)$ of the instruction code is a " 1 " at this time indicating a Left Shift, inverter 1 enables the setting of LS. If $X_{7}=" 0$ ", RS is set.

The RS or LS FFs are cleared by inverter F in the C cycle. Since H06 is not set in the C cycle until V 300 time of the last shift cycle, the clearing of LS or RS at this time indicates the completion of the shifting operation.

In Multiply operations inverter F sets RS in the A cycle of the ROP mode. Since H04 is not set until V200 time of the C cycle for the last multiply iteration, inverter E clears RS at V 225 of the last multiply iteration.

In Divide operations, inverter E sets LS at V100 time (H02 and t25) of the C cycle for each divide iteration. Inverter $F$ clears LS at V 325 time of each iteration. When $\mathrm{Y}_{00-04}=0$ indicating the divide is complete, inverter E clears LS at V225 time of the last iteration.

The V23 module provides eight outputs for the RS and LS enables. One output from each connects to each of the Adder/Shifter modules. The V23 module also provides the $\overline{\text { shift }}$ enable to the Adder/Shifter module. If either the RS or LS is set, inverter $E$ or $F$ on the V23 module enters a " 0 " in the shift enable fan-out. As a result, the $\overline{\text { shift }}$ enable becomes a " 0 ".


| \& CONTROL DATA | Trite |  |  | Penoucr 1704 |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | ${ }^{10278}$ | $\begin{aligned} & \text { DrAnTMO MO. } \\ & 6015270 \end{aligned}$ |  | ${ }_{\text {RV }}$ |
| COMPUTER DIVISION |  |  |  |  | ${ }^{\text {spetet }}$ | Pater |  |

The Adder Gate Control FFs enable the input to the augend and addend gates according to the translaged conditions of the instruction being executed. Only one input is enabled to the augend and/or addend gates at a time. If no input is enabled to the augend or addend gates, the corresponding adder inputs receives -0 . This input enables the adder to add -0 to the other input, such as in a simple register transfer, to perform an exclusive OR, or logical product function.

## AUGEND GATES

Four FFs control the inputs to the augend gates: $A \rightarrow$ Adder, $+1 \rightarrow$ Adder, $\mathrm{Y} \rightarrow$ Adder, and $\mathrm{X} \rightarrow$ Augend. The block diagram ( p .1 ) shows that these four quantities enter the augend gates. Since the X register enters both the augend and addend gates, a separate FF controls the entry of the X register
to the augend and addend gates.

The Augend Control FFs are contained on two V04 modules. The FFs are set at A or $Y$ for display enables the setting of the corresponding control FF at
time too. For example, if $A$ is manually selected, the manual input becomes a " 1 ". The Stopped condition of the computer partially enables inverter I. The to 00 pulse produces a " 1 " output of I which sets the $A \rightarrow$ Adder FF. As a result, the contents of A are displayed on the indicators connected to the Adder outputs.
On Multiply (MUI) or Divide (DVI) operations, the A $\rightarrow$ Adder FF is cleared on every V200 time of the C cycle by inverter 0 .

## A $\rightarrow$ ADDER

The $\mathrm{A} \rightarrow$ Adder FF gates the outputs of the A register to the augend gates of the Adder/Shifter when set. The conditions determining the setting of this FF are enabled at the inputs to the two groups of inverters on the V35 module.

For example, during each shift cycle of a Shift A instruction, the V300 pulse sets the $\mathrm{A} \rightarrow$ Adder FF on both the A cycle and C cycle. This function gates the contents of the A register into the Adder/Shifter for the Shift operation.

For another example, assume that the $\mathrm{X}_{5}$ bit of the IR instruction is set, designating $A$ as the origin register for the inter-register transfer. Thus, in the A cycle portion of the REG mode, the V100 pulse sets the A $\rightarrow$ Adder FF, enabling the transfer of the contents of the A register to the Adder/Shifter.

The Command Timing Sequences list the specific conditions and times for the setting of the A $\rightarrow$ Adder FF for the applicable instruction.

## $+1 \rightarrow$ ADDER

The setting of the $+1 \rightarrow$ Adder FF gates a +1 input to the augend gates of the Adder/Shifter. This input is used mainly to add one to the address of the present instruction ( P ) to get the address of the next instruction. For example, during the A cycle of the ROP mode of all instructions except EXI, MUI, or DVI, the V 300 pulse sets the $+1 \rightarrow$ Adder FF which initiates the advancing of $P$ for the next instruction. The Block +1 function inhibits, through inverter $D$, the setting of the $+1 \rightarrow$ Adder FF which initiates the advancing of $P$ for the next instruction. The Block +1 function inhibits the advancing of $P$ under

In the B cycle of the ADR mode in the RTJ instruction, the $+1 \rightarrow$ Adder FF is set at V100 time. This function performs the $P+1$ function which is stored at the effective address. The $P+1$ value represents the return instruction address following the completion of the subroutine

## $\mathrm{Y} \rightarrow$ ADDER

The $\mathrm{Y} \rightarrow$ Adder is used mainly in address modification functions. In this case the quantity in the Y register which represents base address or partially formed effective address is gated to the adder. The adder adds the quantity to another value in order to form the final effective address.
For example, assume the following conditions: (ADR) (INT) (ind) (q) (A $\neq 0)$ (A cycle). Thus, in an indirect address function, the contents of the Q register ( $q$ index) is added to the base address ( $\Delta$ in the $Y$ register) to form the res the content of the $Y$, Simultansously, th gantents of the $Q$ regis

## $X \rightarrow$ AUGEND

The setting of the $X \rightarrow$ Augend FF gates the contents of the $X$ register to the augend gates. The inputs to the corresponding inverters on the V34 module specify the conditions for setting the $\mathrm{X} \rightarrow$ Augend FF .

For example, in the C cycle of the Mult. Step operation with MB $=1$, the $X \rightarrow$ Augend $F F$ is set at V300 time. This function transfers $X$ to the augend gates while the simultaneous setting of the $Q \rightarrow$ Adder $F F$ gates $Q$ to the addend gates Thus, $Q$ (partial product) is added to $X$ (multiplicand) which produces the next partial product or final product in the case of the last Mult. Step.


## ADDEND GATES

Four FFs control the inputs to the addend gates: $\mathrm{Q} \rightarrow$ Adder, $\mathrm{X} \rightarrow$ Addend $\mathrm{P} \rightarrow$ Adder, and Mask $\rightarrow$ Adder. Thus, the setting of one of these FFs transfers the output of the corresponding register to the addend gates of the Adder/Shifter. Only one of the Addend Control FFs is set at a time. If none of these FFs are set, the addend gates receive an input of all ${ }^{\prime \prime} 1^{\prime} s^{\prime \prime \prime}$.

The Addend Control FFs are contained on two V04 modules. The FFs are set at V100 (H01 and t00) or V300 (H05 and t00). The manual selection of Q, X, P, or Mask for display enables the setting of the corresponding control FF at time t00. The FFs are set in the display condition in the same manner as the Augend Control FFs
The Command Timing Sequences list the times and specific conditions for setting the Addend Control FFs

## Q. $\rightarrow$ ADDER

When set; the $\mathrm{Q} \rightarrow$ Adder FF gates the output of the Q register into the addend gates of the Adder/Shifter. The inputs of two groups of inverters

An example of the setting of the $\mathrm{Q} \rightarrow$ Adder FF is made by assuming the following conditions: (ADR) (INT) (ind) (q) ( $\overline{\mathrm{RNI}}+\Delta=0$ ). Thus, the contents of $Q$ ( $q$ index) are added to the base address to form the effective address. At V300 time of the A cycle ( H 005 and t00), the output of inverter J on the V04 module sets the $\mathrm{Q} \rightarrow$ Adder FF.

During MUI or DVI operations, the $\mathrm{Q} \rightarrow$ Adder is set at the V300 time of the A cycle during the ROP mode. In a Multiplication operation, this action initiates the initial adding of $Q$ to the multiplicand in $X$ if $M B$ is set. On each following Mult. Step, the $\mathrm{Q} \rightarrow$ Adder FF is reset at V300 of the C cycle

## $X \rightarrow$ ADDEND

The inputs to the four corresponding inverters on the V33 card specify the conditions for setting the $\mathrm{X} \rightarrow$ Addend. For example, the V100 pulse sets the $\mathrm{X} \rightarrow$ Addend FF on every A cycle of the ROP mode

In addressing operations $\overline{\operatorname{RNI}(\Delta=0)}$ (ADR), V100 of the A cycle sets the $\mathrm{X} \rightarrow$ Addend FF. This operation transfers the base address in X to the $X \rightarrow$ Addend $F F$. This operation transfe

## $P \rightarrow$ ADDER

The setting of the $\mathrm{P} \rightarrow$ Adder FF transfers the current program addres in P to the adder for modification. In most cases, $\mathrm{a}+1$ is added to P to obtain the address of the next sequential instruction. Thus, at V300 of the A cycle in the ROP mode of all instructions except EXI, MUI, or DVI the $\mathrm{P} \rightarrow$ Adder FF is set simultaneously with the $+1 \rightarrow$ Adder (augend gates) which adds +1 to $P$.

The V300 pulse sets the $\mathrm{P} \rightarrow$ Adder FF in the A cycle of the STO mode of every applicable instruction. The $P \rightarrow$ Adder FF is also set at the V300 time of the A cycle in the REG mode of every applicable instruction except during Shift Cycle operations.

MASK $\rightarrow$ ADDER
The Mask $\rightarrow$ Adder FF is set at V100 time of the A cycle only on IR instructions when bit 3 of the X register is set (Mask is origin register) In this case, the contents of the Mask register transfers to the adden gates of the adder for subsequent transfer to the selected destination register.


## ADDER/SHIFTER FAN-IN GATES (AUG)

The augend (AUG) gates of the Adder/Shifter receives enables from the augend adder gate controls which enable the inputs from the corresponding register. Thus if the $X \rightarrow$ Augend $F F$ on the augend gate control module is set, the $\bar{X} \rightarrow$ $\overline{\text { Augend }}$ input to each of the AUG gates becomes a " 0 ". The resulting " 1 " output from inverter $B$ enables the inputs from the $X$ register into the corresponding inverters on the AUG gate modules.

The AUG gates are contained on four V03 modules. The bit positions on each module are divided in pairs according to the chassis locations of the V03 module and the adder/shifter module to which they connect. For example, bit positions 1 and 2 are on the V03 module at location C53. Bit positions 1 and 2 for the Adder/Shifter are on the V00 module at location C55. This system is used to reduce the lengths of the connecting wires between the two modules to a minimum.

Each bit position on the V03 modules consists of four input inverters and a True and Not output inverter. When one of the enables from the augend gate controls in a " 0 ", the corresponding inverter ( $\mathrm{A}, \mathrm{B}, \mathrm{C}$, or D ) enables the corresponding bit position inputs. The " 1 " inputs from the selected register produce " 1 " outputs on the AUG-lines and " 0 " outputs on the $\overline{A U G}$-lines. If none of the enables is a " 0 " indicating that no input is selected for the augend gates, inverter E produces a " 0 " output. All the AUG- outputs now become " 1 ' $s$ " whenever no input is selected for the AUG gates.

In the case of a $+1 \rightarrow$ Adder selection, inverter $D$ enables a GND (" 1 ") input to bit position 0 and $1.2 \mathrm{v}(" 0$ ") inputs to the remaining bit positions. Thus, the Adder/Shifter receives a +1 input from the AUG gates.


## ADDER/SHIFTER FAN-IN GATES (ADN)

The addend (ADN) Adder/Shifter fan-in gates receive enables from the addend adder gate controls which enable inputs from the corresponding register. If a particular Addend Adder Control FF is set, the enable to the ADN gates becomes a " 0 ". The output of the corresponding inverter ( $\mathrm{A}, \mathrm{B}, \mathrm{C}$, or D ) enables the input from the selected register into the ADN gates. The True and Not outputs
of the ADN gates connect to the Adder/Shifter modules.

The ADN gates function in the same manner as the AUG gates as described on page 53.


| C CONTROL DATA | Trite |
| :---: | :---: |
|  | ADDER SHIFTER FAN-IN ADDEND (ADN) GATES |
| COMPUTER DIVISION | ADDEND (ADN) GATES |

## GROUP 0 OF ADDER

## ADDER LOGIC

The adder portion of group 0 is contained on the V60 module. The adder logic functions on this module in an identical manner to the equivalent logic on the other groups of the adder (page $59^{\circ}$ ). However, in place of the group borrow input, the V60 module receives the Section 1 Borrow + (Section 0 Borrow) (Section 1 Enable) conditions. Thus, group 0 of the adder receives a group borrow input from a Section 1 Borrow or from a Section 0 Borrow and a Section 1 Enable.

## End Around Borrow (EAB)

A stage 15 borrow (H) or a stage 15 enable (E15) and a group borrow input corresponds to an EAB condition. In the V60 module, the EAB functions the same as a stage borrow in the other modules since stage 0 is contained on the same module.

## OVERFLOW

The V60 module detects the Adder Overflow condition. The Adder Overflow occurs when the result of an arithmetic operation exceeds the modulus of the adder in the ones complement system. An overflow can occur in the positive or negative direction. The overflow condition can also be expressed logically as follows:

$$
\begin{aligned}
\text { Overflow }= & (\text { S15B })\left(\text { Bit } 15=^{\prime \prime} 11^{\prime \prime}\right)+\left(\text { Bit } 15=^{\prime \prime} 0^{\prime \prime}\right)(\mathrm{S} 15 \mathrm{~S}) \\
& \text { S15B }- \text { Stage } 15 \text { borrow } \\
& \text { S15S }- \text { Stage } 15 \text { satisfy }
\end{aligned}
$$

The first two terms correspond to a positive overflow and the second two to a negative overflow. Simplified examples of both types are as follows.

3210 Bit Positions
0111 Augend $\left(+7_{8}\right)$
0111 Addend $\left(+7_{8}\right)$
-1111 Stage Difference
1110 Borrow Corrected Difference (-1) EAB

Positive Overflow
3210 Bit Position
1000 Augend $\left(-7_{8}\right)$
1000 Addend $\left(-7_{8}\right.$
1111 Stage Difference
$0<-0<-0<-1 \quad$ Borrow Corrected Difference ( +1 )

## Negative Overflow

In the first example, the sum of the two positive numbers exceeds the modulus of the simplified adder. This condition corresponds to the first two terms in the logical equation above. Thus, the detection of an EAB and a " 1 " in stage 15 of the sum denotes a positive overflow.

The second example shows a negative overflow. In this example, the sum of two negative numbers exceeds the modulus of the simplified adders. A negative overflow is detected when bit 15 is a " 0 " (positive result) and bit 15 of the augend and addend produce a satisfied condition.

The detection of an overflow on the V60 module produces a " 0 " output on pin 27. The enabling of either the two main input gates sets the Overflow FF (H) on the V58 module. For example, V275 (H005 and t75) sets H on the $B$ cycle during the ROP mode on an ADD instruction if an overflow is detected.

In an Inter Register instruction, the setting of bits 6 or $7\left(X_{6}\right.$ or $\left.X_{7}\right)$ of the instruction code denoting an Exclusive Or or Logical Product disables the setting of H . Thus, the setting of H is disabled unless the overflow resulted from an arithmetic Add or Subtract operation.

An overflow can also result from a divide instruction. In this case, an overflow results when the quotient in the A-register becomes negative at the completion of the Divide operation ( $\overline{\text { Divide Step }}$ ). An overflow during a Divide instruction occurs when the answer exceeds the modulus of the 16-bit register.

The Overflow FF is also set at V275 time of the A cycle during an Exit Interrupt (EXI) instruction if bit 15 of the word read from storage (containing the return address) is a " 1 ". A " 1 " in this position denotes the Overflow FF was initially set at the time the interrupt occurred. If $X_{15}$ is $a^{\prime \prime} 0$ " at this time, H is cleared.

In an Interrupt operation (INT), the state of the Overflow FF transfers to bit 15 of the addend gates. The $P \rightarrow$ Adder command is also enabled at this time. Since the $P$ register now contains the return address for the EXI instruction, the state of the Overflow FF is combined with the return address.

The Sense Overflow command during a Skip instruction clears H at V275 of the A-cycle. The setting of the Overflow FF also lights the Overflow Fault indicator during the Display mode.

## SHIFTING OPERATIONS

Shifting operations for group 0 of the adder take place on the V61 module. Left or right short shifts take place in the same manner as in the other groups of the adder. In the case of left shifts, which are always endaround, bit 15 transfers from pin 21 to the V60 module to pin 14 of the V61 module. The LS enable shifts bit 15 to the bit 0 output. Bit 0 transfers from pin 16 of the V60 module to the group 1 V00 module (page 59 ). The LS enable shifts bit 0 to the bit 1 output.

All right shifts (RS) are end-off. Thus, bit 1 shifts to the bit 0 output of the V61 module. The bit 0 output is not used in RS operations. Bit 15 transfers from pin 23 of the V 60 module to the group 7 V 00 module (page 65). The RS enable shifts bit 15 to the bit 14 output. Since it is assumed that the LRS2 and MUI controls are not enabled in this case, bit 15 transfers to the bit 15 output of the V61 module, extending the sign.

Long Shift

A long shift takes place when both bits 5 and 6 of the Shift instruction are " 1 ", indicating that both $A$ and $Q$ are to be shifted. A long shift also takes place for each iteration of a Multiply or Divide instruction. In any of these instructions, V125 (t25 and H02) sets the Long Shift FF. The setting of the Long Shift FF enables a LLS2 or LRS2 operation depending on whether a left or right shift is selected.

Long Left Shift (LLS): The LLS operation takes place in two steps: LLS and LLS2. The LLS1 operation is enabled by the following conditions:

LLS1 $=($ MUI + DVI + Shift QA $)(\overline{\text { Long Shift }})(\mathrm{LS})$

Thus, LLS1 takes place before the setting of the Long Shift FF, which enables LLS2.

In a typical LLS operation (fig. 1 , page 56,2 ), Q is shifted first followed by the shift of $A$. In the shift of $Q$, LLS1 enables the shift of bit 15 of $A$ directly to the output of bit 0 of $Q$ on the V 61 module. At V100 time (t00 and H01), Q15 transfers from the V60 module to set the Bit Bucket FF. The Bit Bucket FF retains the state of Q15 until the shift of A. At V125 time, the Long Shift FF is set which disables LLS1 and enables LLS2. The LLS2 enables the shift of the bit bucket to bit 0 of the shifted A output.

During Divide Step operations, the detection of the $\overline{\mathrm{EAB}}$ condition which indicates that $(Q) \geq(X)$ sets the bit bucket at V100 time. The contents of the bit bucket is shifted to bit 0 of the shifted A output.

Long Right Shift (LRS): The setting of the Long Shift FF enables LRS2. The LRS2 output enables the shift of the state of the bit bucket to the bit 15 output of $A$.

During (QA) or MUI operations, bit 0 of $\mathbf{Q}$.transfers to the bit bucket on the shift of Q . Bit 0 subsequently shifts from the bit bucket to bit 15 of the A output. Fig. 2, page 56.2, shows a simplified illustration of a LRS operation.


Fig. 1 -- Simplified Example Of LLS.


Fig. 2 -- Simplified Example Of LRS.


【 The block diagram in Figure 3 to the right shows that the Adder/Shifter circuit is divided into three main divisions:

1) Adder/Shifter modules (V00) - perform stage borrow and enable, shifting, Exclusive OR, and Logical Product functions.
2) Borrow Look - Ahead modules (V10) sense stage borrow and enable conditions. The V10 modules produce group borrow and section borrow and enable conditions.
3) Fan-out modules (V06) provide the required number of outputs from the Adder/Shifter to the registers indicated.

## ADDER PYRAMID

One of the main functions of the Adder/Shifter is the adding operation. The adder is divided into eight groups. Each group is contained on a V00 module. All groups except group 0 are logically identical. Thus, the following description is based on the operation of a typical group of the adder (group 1). The basic logical operation of group 0 is similar to the other groups. However, this group contains some additional features and is described separately on page 56.1.

## STAGE BORROWS AND ENABLES

Figure 3 shows that each group operates on two adjacent bits of the addend and augend. (Bits 0 and 15 are considered adjacent bits in the adder pyramid.) Thus, group 1 compares bits 1 and 2 of the augend and addend.

The adder pyramid uses a subtractive pyramid circuit to perform the Add function: AUG $-(-A D N)=A U G+A D N=S U M$. The principles of a subtractive pyramid are shown in Figure 4.

A stage borrow results whenever a " 1 " is subtracted from a " 0 ". Thus, in Figure 4, the borrow generated in stage 0 propagates to stage 1 where it is satisfied. Enables result when a " 1 " is subtracted from a " 1 " or a " 0 " from a " 0 ". Enables propagate borrows but are toggled as a borrow passes through as shown in Figure 5.


Figure 3. Adder/Shifter Block Diagram


Figure 4. Principles of a Subtractive Pyramid

stage no.
minuend
subtrahend
Stage differences
borrows
enables
F}<<1<0<1 BORROW PROPAGATIO
F}<<1<0<1 BORROW PROPAGATIO
' \
' \
END AROUND (+4)-(+7)=-3
END AROUND (+4)-(+7)=-3
BORROW

Figure 5. Example of Borrow Propagation

Figure 5 shows that the borrow generated in stage 0 propagates to stage 1 which it toggles. Stage 1 also generates a borrow which propagates through enables at stages 2 and 3 which are toggled. The end-around borrow toggles the stage 0 difference which produces the final difference.

Since the output of the subtractive pyramid is a sum, the ADN inputs are complimented in the stage comparisons according to the principles shown in Figure 6.


## Figure 6. Principles of the Adder Pyramid

Because the addend bits are complimented in the bit comparisons, Figure 6 shows that a " 1 " subtracted from a " 0 " or a " 0 " from a " 1 " produces an enable. The subtraction of a " 1 " from a " 1 " results in a satisfy while the subtraction of a " 0 " from a " 0 " produces a borrow. All other logical conditions for a subtractive pyramid apply to the adder. The example in Figure 6 shows the final sum of $+13{ }_{8}$ for the quantities used.

The stage borrow and enable conditions are sensed at the input inverters on the V00 modules. The enable for stage 1 (SIE) is defined by the following logical equation: $\operatorname{SIE}=[($ AUG 1 $)(\overline{\mathrm{ADN} 1})+(\operatorname{ADN~1})(\overline{\mathrm{AUG} \mathrm{1}})](\overline{\mathrm{LP}})$

If the $\overline{\mathrm{LP}}$ term is disregarded in this case, the SIE condition is sensed when the corresponding bits in the augend and addend are unlike. This logical arrangement corresponds to the example in Figure 6.

The stage 1 borrow ( $\mathrm{S}_{1} \mathrm{~B}$ ) is defined by the following equation:

Disregarding the $\overline{L P}$ term, a stage borrow results when corresponding bits in the augend and addend are both " 0 's", which also corresponds to Figure 6. The stage borrow and enable conditions are sensed in the same manner on all V00 modules.

## Borrow Propagation

The propagation of borrows in the V00 modules takes place in the following three ways:

1) Borrows generated by the low-order adjacent stage within a group.
2) Borrows generated by the high-order stage within a group (group borrow).
3) Borrows generated by the adjacent lower-order group.

A case 1 borrow propagates directly to the adjacent stage in the group, regardless of the group borrow input to the generating stage. For example, assume a borrow input to stage 1 of group 1 exists. Inverter $*$ produces a " 0 " output which propagates the borrow directly to stage 2 through the interconnecting inverter, regardless of the group 0 borrow input.

Case 2 borrows are transmitted to the group borrow logic on the corresponding V10 module through pin 8 on the V00 module. For example, assume a borrow input to stage 2 of group 1. The $\overline{\mathrm{S}_{2} \mathrm{~B}}$ output on pin 8 becomes a " 0 ", indicating a stage 2 borrow. The $S_{2} B$ condition corresponds to a group 1 borrow which is described in more detail in a subsequent paragraph.

The case 3 borrows probe the enable condition of the low-order stage in a group. If an enable exists in that stage, the output of that stage becomes a " 1 " (toggled) and the borrow is propagated to the adjacent stage in the group. For example, assume a group 0 borrow input to group 1. The group 0 borrow input probes the output of inverter $\mathrm{E}_{1}$ through the interconnecting inverters. If an enable exists in stage $1, \mathrm{E}_{1}$ produces a " 1 " output and the group 0 borrow propagates to stage 2 where it probes the $E_{2}$ output. If the group borrow probe detects an enable in a stage, it forces the output of that stage to a " 1 " corresponding to the toggling of the " 0 " output in the partial sum.

GRȮUP BORROWS
Each group produces three outputs to the corresponding section (V10) module. These outputs determine whether a borrow is generated by the corresponding group. For example, group 1 produces the $\overline{\mathrm{S}_{2} \mathrm{~B}},\left(\overline{\left.\mathrm{~S}_{1} \mathrm{~B}\right)\left(\mathrm{S}_{2} \mathrm{E}\right)}\right.$ and $\left(\overline{\left.\mathrm{S}_{1} \mathrm{E}\right)\left(\mathrm{S}_{2} \mathrm{E}\right)}\right.$ conditions from pins 8,1 , and 3 respectively.

The corresponding V10 module generates group borrow, section borrow, and section enable outputs according to the enable and borrow condition of the groups in that section. The section 0 module, for example, generates group borrows for groups $0,1,2$ and 3 . The group 3 borrow corresponds to the section 0 borrow. The following logical equations represent the group borrow function for a typical group (group 1) in section 0.

```
Group 1 Borrow \(=[\mathrm{S} 2 \mathrm{~B}+(\mathrm{S} 1 \mathrm{~B})(\mathrm{S} 2 \mathrm{E})]+[(\mathrm{S} 1 \mathrm{E})(\mathrm{S} 2 \mathrm{E})(\mathrm{SOB})+(\mathrm{S} 1 \mathrm{E})\)
(S2E) (S0E) (S15B) \({ }^{+}+[(\mathrm{S} 15 \mathrm{E})(\mathrm{S} 0 \mathrm{E})(\mathrm{S} 1 \mathrm{E})(\mathrm{S} 2 \mathrm{E})(\mathrm{J})]\)
J (Section 0 Borrow Input) \(=\) Section 1 Borrow + (Section 1 Enable) (Section 0 Borrow)
```

The equations above show that in general a group borrow results when any of the following conditions are present:

1) The higher-order stage in the group generates a borrow.
2) The higher-order stage in the group produces an enable and the lower order stage in the group generates a borrow.
3) A stage in a lower-order group generates a borrow and all higherorder stages in all groups up to and including the generating group produce enables. This condition is represented by the third term in the group 1 borrow equation.

The group borrow outputs go to the next higher-order group.

## SECTION BORROWS

The section borrows are generated on a V10 module when a borrow propagates through all the groups in a section. For example, the borrow can either originate in section 0 or originate in section 1 and propagate through section 0 .

## ADDER/SHIFTER (Cont'd)

Section borrows are generated under the same conditions as a group borrow. Thus, the section borrow can also be termed the group 3 borrow because group 3 is the highest order group in section 0 . Figure 7 shows a simplified example of a section borrow.

In Figure 7, the borrow originates in group 3 and propagates to section 1 as the section 0 borrow. Since all the groups in section 1 generate enables, the borrow propagates through section 1 . The combination of a section 1 enable and section 0 borrow enters a borrow input to section 0 .

## SECTION ENABLES

Each section generates a section enable when all the groups in the section produce enables. In Figure 7, section 1 generates an enable because groups 4-7 all produce enables.


Figure 7. Simplified Section Borrow

## ADDER OUTPUTS

The output of the B -inverters on the V00 modules represents the output of the corresponding stage of the Adder. For example, $\mathrm{B}_{1}$ on the group 1 module represents the output of stage 1 of the Adder. The Adder outputs connect to the Shifter circuit, to the corresponding indicator light and to the fan-out module. The logical equation below represents the conditions for a typical Adder output.

$$
\begin{aligned}
& \mathrm{B}_{1}=\left(\mathrm{E}_{1}\right)(\text { Group } 0 \text { Borrow })(\overline{\mathrm{LP}})+\left(\mathrm{E}_{1}\right)(\mathrm{XR})+(\overline{\mathrm{XR}})(\mathrm{LP})(\text { AUG } 1) \\
& (\mathrm{ADN} 1)+(\overline{\mathrm{XR}})(\overline{\text { Group } 0 \text { Borrow }})(\overline{\mathrm{LP}})(\overline{\mathrm{AUG} 1})(\overline{\mathrm{ADN} 1})
\end{aligned}
$$

By assuming ( $\overline{\mathrm{LP}})(\overline{\mathrm{XR}})$ conditions, the above equation becomes:
$B_{1}=\left(E_{1}\right)($ Group 0 Borrow $)+(\overline{\text { Group } 0 \text { Borrow }})(\overline{\text { AUG 1 }})(\overline{\text { ADN } 1})$
Thus, stage 1 of the Adder produces a " 1 " output with a stage 1 enable and a group 0 borrow or a stage 1 borrow and no group 0 borrow. In all other borrow and enable conditions, $\mathrm{B}_{1}$ produces a " 0 " output. With the exception of Shift operations, $B_{1}$ represents the output of stage 1 of the Adder/Shifter.

## LOGICAL PRODUCT

The Adder/Shifter modules also perform Logical Product (LP) operations. The LP function produces a " 1 " output from a stage of the Adder that corresponds to " 1 's" in the same bit position of the addend and augend as shown by the simplified example below.


Setting the LP Control FF enables the input to each V00 module. Assuming an $(\mathrm{LP})(\overline{\mathrm{XR}})$ condition, the output of inverter A blocks all inputs to $\mathrm{B}_{1}$ except the input corresponding to the third term in the equation for $B_{1}$ above. Thus, $B_{1}$ produces a " 1 " output on an LP operation when stage 1 of the augend and addend both contain "1's".

## EXCLUSIVE OR

The Adder/Shifter modules perform Exclusive OR (XR) functions. The XR function produces a " 1 " output from a stage of the Adder that corresponds to
a " 1 " in the same stage of the addend or augend but not both as shown below:

| $15-\cdots 210$ | Bit Positions |
| :---: | :---: |
| $0-\cdots 1010$ | Augend |
| $0-\cdots-1100$ | Addend |
| $0-\cdots 110$ | Result |

The setting of the XR Control FF enables the XR input to all V00 modules. Assuming the (XR) ( $\overline{\mathrm{LP}})$ condition, the " 0 " output of inverter $B$ blocks all inputs to $B_{1}$ except the $\left(E_{1}\right)(X R)$ term. Since the $E_{1}$ output represents an enable condition (the bits in stage 1 of the addend and augend are different), $\mathrm{B}_{1}$ produces a " 1 " output.

## SHIFT CIRCUIT

In a Shift operation, the operand in the $A$ or $Q$ register is shifted a specified number of positions left or right. The bits in the designated register are shifted one position each time the operand is transmitted through the Adder/ Shifter. In (QA) Long Shift operations, the operands in the A and Q register are shifted separately in the Shift circuit for each shift cycle.

The shifting operation takes place on the V00 modules at the output of the Adder. Thus, the outputs of the B-inverters are shifted left or right one position.

The setting of the LS or RS Control FFs transmits a " 0 " to the $\overline{\text { Shift }}$ input to each Adder/Shifter module. This input disables the normal output of the B-inverters. Thus, the LS or RS paths determine the output of each stage of the Adder/Shifter modules.

In a shifting operation, the LP FF is set coincident with the $\overline{\text { Shift }}$ and LS or RS enables. As a result, the LP input enables an LP operation in the Adder at the same time as the shift. The operand is gated into the augend or addend gates, and the gates not selected receive an input of all "1's". The output of the B inverters represents the operand.

LEFT SHIFT
The Left Shift takes place on the Adder/Shifter modules when the LS Control FF is set. The LS enable enters each Adder/Shifter module. Since the Shift enable blocks the normal output of the B-inverters, the outputs of these inverters are enabled by the LS input. Thus, the B outputs, which represent the bits of the operand, appear as outputs shifted one position to the left.

All Left Shifts are end-around. Thus, on a Long Left Shift (LLS), the bit in stage 15 of $Q$ shifts to stage 0 of $A$. The LLS function is described in more detail in the Adder Group 0 section (page 57). In the Short Left Shifts, bit 15 shifts to bit 0 . The simplified illustration in Figure 8 shows an example of a Left Shift operation of (A).


Figure 8. Example of an (A) Left Shift

Figure 8 shows the bit positions of the Adder outputs relative to their positions in the groups. For example, the stage 0 output is shown adjacent to the stage 15 output in group 0 . The shift of the low-order stage of a group to the highorder stage takes place on the corresponding V00 module. The output of the high-order stage on a group transfers to the output of the low-order stage on the adjacent high-order group.

## RIGHT SHIFT

The setting of the RS Control FF enables the RS input to each Adder/Shifter module. The $\overline{\text { Shiift }}$ input disables the normal Adder output. Thus, the RS enable shifts the output of the $\mathrm{I} \& \mathrm{C}$-inverters one position to the right: All right shifts are end-off. Thus, the bit in stage 0 is lost. The sign bit (stage 15) is extended. If the sign bit is initially negative ("1"), the stage 15 output remains a " 1 " for each shift as the other bits shift to the right.

## MANUAL SET AND DISPLAY

The Adder/Shifter modules serve as the means of manually setting and displaying the output bits of the selected register. Each manual set switch on the console connects to the corresponding output stage of the Adder/Shifter modules. Pressing the manual set switch during the Display mode enters a " 0 " into the output inverter on the V00 module. The output becomes a " 1 ".

The output of the selected register enters the Adder/Sthifter modules through the addend or augend gates. The gates not selected receive an input of all " 1 's". In the Display mode, the LP FF is also set. Thus, a Logical Product operation takes place between the selected register and all " 1 's". The contents of the selected register are displayed on the indicator lights connected to the output of each stage of the Adder/Shifter. The Manual Controls (see dislay example, page 21) describes the manual set and display operation in more detail.

## FAN-OUT MODULES

The output stages of the Adder/Shifter connect to the output registers (A, Y, X , etc.) through fan-outs on the V06 modules. Each fan-out produces six outputs, required by the number of registers that connect to the Adder/Shifter.

## ADDER/SHIFTER TIMING

The Adder/Shifter operates in a static mode. Thus, the input is gated into the Adder at a timed period and the output is gated at a timed period. In all operations except short cycles ( SC ) the output of the Adder is gated into the enabled register 200 nsec after the input was enabled. This delay allows sufficient time for the Adder circuit to stabilize.

In most cases, the enabled input is gated to the Adder at the same time as the output of the Adder is gated to the enabled register. The input data does not interfere with the output since the minimum path through the Adder of eight inversions (including fan-out) is a sufficient delay.

Figure 9 shows the Adder timing sequence for an Add to A (ADD) instruction. In this instruction, an operand is read from storage and is transferred to the $X$ register from where it is added to the contents of the A register. The example shows only those commands that apply to the Adder.

In the first Adder cycle (A cycle), the operand in the X register is gated to the addend gates at 100 time. However, the output is not used. At 300 time, (P) and +1 are combined in the Adder to give the address of the next instruction. At 50 time of the B cycle, storage is requested which initiates the reading of the next instruction. At 100 time ( $\mathrm{P}+1$ ) transfers from the Adder to Y and P at the same time ( X ) and ( A ) are transferred to the addend and augend gates respectively. The output sum $(A+X)$ transfers to the $A$ register at 300 time.

## SHORT CYCLE (SC) OPERATIONS

During SC operations, as in Shift and Multiply instructions, the output of the Shifter is gated 100 nsec after the gating of the selected input. A delay of 100 nsec is sufficient for these operations since the full Adder circuit is not used. Figure 10 shows the Adder timing sequence in a Shift (A) instruction for a portion of one C cycle.

## ADDER/SHIFTER (Cont'd)


a cycle
(ROP-RNI MODES)


Figure 9. Example of Adder Timing Sequence in a Normal Cycle


Figure 10. Example of Adder Timing Sequence in a Short Cycle






Module V54 contains three FFs which control program protect and protect violations. The Instruction Protected FF retains the state of the previous instruction. If the FF is set, the previous instruction was protected. If the FF is clear, the previous instruction was not protected. An interrupt occurring during the B cycle also sets the Instruction Protected FF. Thi simulates a protected operation while writing a return address.

Whenever a violation of the program protect system is detected, the Protect Fault FF sets and an internal interrupt is enabled. A 00 interrupt occurs if mask bit 00 is set and the interrupt system is active. A violation indicates that the nonprotected program has attempted an operation which could harm the protected program. The four program protect violations and their setting inputs to the Protect Fault FF are:

## Violation

1. A nonprotected instruction attempts to write into a storag location containing a protected instruction/operand The contents of the storage location are not changed.
2. An attempt is made to write into a protected storage location tion was the ultimate source of the a
the storage location are not changed.
3. An attempt is made to execute a protected instruction following execution of a nonprotected instruction. The
from
inverter J protected instruction is executed as a nonprotected Selective Stop instruction. It is not a violation, however, if an
interrupt caused this sequence of instructions.
4. An attempt is made to execute the following instructions when they are not protected: Interregister with bit $0=1$, EIN, IIN, EXI, SPB, or CPB. These instructions become nonprotected Selective Stop instruction under these circumstances.

The FF at the bottom of module V54 sets when violation number 3 is present. The output of this FF blocks the setting of the ADR FF and sets the REG FF in the Sequence controls. Therefore, if either violation 3 or 4 is present and REG mode selected, the $F$ register clears. The computer recognizes the 00 code in the $F$ register as a Selective Stop instruction. If the Selective Stop switch is in the stop position, the computer stops. If the switch is in the neutral position the instruction is executed as a nonprotected pass instruction. A " 0 " output at pin 6 clears the upper portion of the $X$ register.

All three FFs on module V59 must be set for the computer to process an interrupt. The order of events for enabling the interrupt system is as follows:

1) Set first Enable Interrupt FF
2) Set second Enable Interrupt FF (interrupt system active)
3) Set Interrupt registers
4) Interrupt priority is checked
5) Interrupt FF is set (there is an interrupt)

The first Enable Interrupt FF is set at time 250 of the B cycle during REG of an Enable Interrupt or Exit Interrupt instruction. The second Enable Interrupt FF sets at time 200 of the B cycle when the $\overline{\text { ADR (ind) }}$ condition is present and the first Enable Interrupt FF is set. For the Enable Interrupt instruction, this delay allows one more instruction to be executed before enabling the interrupt system. There is no delay when using the Exit Interrupt instruction.

At time 50 of the A cycle, the second Enable Interrupt FF sets the Interrupt register, providing the Interrupt FF is cleared. The Interrupt FF must be cleared to insure that an interrupt is not in process at the same time the Interrupt register is being set.
are present:

1) The second Enable Interrupt FF set
2) Interrupt signal present from interrupt priority
3) ADR (ind) + RNI

The interrupt occurs reading an instruction from storage or reading an indirect address.

Two main gates clear all three FFs and disable the interrupt system. The first gate clears all three FFs when an interrupt state is entered and the following conditions exist

1) $\quad$ A cycle
2) 

time 300
3) $\frac{\mathrm{ADR}}{\mathrm{RNI}}$ (ind

This gate disables interrupt while the computer stores the registers and sets the new mask. The second gate clears the FFs and disables interrupt when the following conditions exist

1) A cycle
2) REG (ITN)

This gate disables interrupt while the computer restores the registers in preparation of exiting from an interrupt state.


NOTES:
(1) denote page number from low speed computer diagrams.
(2) (PROTECT FAULT) (RNI)A (VOSO)(SWEEP + ENTER)


The basic 1700 Computer has two interrupts. They are as follows:

1) Interrupt state $00=$ (internal) Storage Parity Error,

Program Protect Fault, or Power Failure
2) Interrupt state $01=$ (external) Low-Speed I/O

An option may be added which gives an additional 14 external interrupt lines. Thus, the computer may have 16 different interrupts. The discussions that follow assume the computer has 16 interrupts


1705 OPTION ADDS
5 ADDITIONAL EX-
TERNAL INTERRUPT
IINES (ADDS 14 INTER-
RUPTS)

## MASK REGISTER

The 16 -bit Mask register is the enable for each interrupt state or line. Bit 00 of the Mask register corresponds to interrupt line 0 , bit 01 to line 1 , etc. To enable an interrupt line, its corresponding bit in the Mask register must be set. The Mask register is set by the Inter-Register instruction.

Module V09 shows the first 4 bits of the Mask register and Interrupt register. Three additional V09 modules are added if 16 interrupts are used. The Mask register is set by the Adder $\rightarrow$ Mask Control FF on module V44. The output of the Mask register returns to the Adder/Shifter.

ADDER $\rightarrow$ MASK CONTROL
The Adder $\rightarrow$ Mask FF has two main setting gates. The first gate is satisfied if the manual Mask register selector on the console is activated and the $\mathrm{Q} \rightarrow$ Adder FF is set. At time V250 of the A cycle, the second gate is enabled if ( E the destination register during an Inter-Register instruction. The Mask register sets at time 300 according to its selected Adder/Shifter inputs if the Adder $\rightarrow$ Mask FF is set

## INTERRUPT REGISTER

The 16 -bit Interrupt register is a holding register for the 16 interrupt lines and sets if all of the following conditions are present

1) The corresponding bit in the Mask register must be set.
2) The corresponding interrupt line signal present.
3) The Enable Interrupt FF set (by an EXI + EIN instruction), t50 (A cycle), and INT FF clear.

INTERRUPT PRIORITY
The interrupt priority consists of modules V11 and V12. When one of the Interrupt register bits sets, the priority network recognizes which interrupt line is present and forms a 4 -bit code. The code specifies $\Delta$ for the Exit
instruction from that particular interrupt state. For example, if the priority input comes from Interrupt register bit 07, then the output code is a binary 0111 The first three columns in Table 1 show the relationship between interrupt states, $\Delta$ portion of EXI instruction, and location of the return address. When an interrupt state is recognized, the $\Delta$ portion of the EXI instruction is formed. Delta defines the interrupt state from which the exit is taken. The EXI instruction automatically reads the address containing the return address and jumps to the return address.

$\triangle$ PORTION OF EXI INSTRUCTION

If two or more interrupts have equal priority and occur at the same time, the computer recognizes the lowest interrupt line. For example, if interrupt states 05 and 12 occur at the same time, the priority network recognizes interrupt 05 and forms a binary output code of 0101.

The interrupt state priority code output transfers to the Y register via the V22 module on page 41

TABLE 1. INTERRUPT STATE DEFINITIONS

| Interrupt State $_{10}$ | Value of $\Delta$ to Exit State ${ }_{16}$ | Location of Return Address | Location of First Instruction After Interrupt Occurs ${ }_{16}$ |
| :---: | :---: | :---: | :---: |
| * $\{00$ | 00 | 0100 | 0101 |
| 201 | 04 | 0104 | 0105 |
| [02 | 08 | 0108 | 0109 |
| 03 | OC | 010C | 010D |
| 04 | 10 | 0110 | 0111 |
| 05 | 14 | 0114 | 0115 |
| 06 | 18 | 0118 | 0119 |
| 07 | 1 C | 011 C | 011D |
| * 08 | 20 | 0120 | 0121 |
| 09 | 24 | 0124 | 0125 |
| 10 | 28 | 0128 | 0129 |
| 11 | 2 C | 012C | 012D |
| 12 | 30 | 0130 | 0131 |
| 13 | 34 | 0134 | 0135 |
| 14 | 38 | 0138 | 0139 |
| 15 | 3C | 013 C | 013 D |

*Interrupts in basic computer
** Interrupts added by 1705 Interrupt/Data Channel option


The Z 94 module contains the logic that controls the shift instructions. Shift instructions are identified by a zero instruction field ( $F$ ) and a hexidecimal $F$ in the sub-instruction field ( $\mathrm{F}^{1}$ ) Bit positions X05-07 identify the type of shift instruction. Below is the format for the shift instructions.


The Shift Cycle FF controls the shifting required by the shift instructions. The first shift occurs during the A cycle and the remaining shifts occur during the C cycle. At time 250 of the A cycle, the shift count (currently in bit positions X00-04) is sensed for a count of zero. If the shift count is zero, the Shift Cycle FF is not enabled and the logic proceeds to B cycle RNI. If the shift count is not zero, the Shift Cycle FF is set and a shift occurs. The shift count then replaces the lower 5 bits of the $Y$ register and is decremented by one. The $Y$ register now contains the shift count.

At time 250 of each pass of the C cycle, a shift occurs and the shift count decrements by one. The logic proceeds to B cycle RNI when the shift count decrements to zero and at time 250 of the C cycle.

The SR1 and SR2 FFs on the V65 modules sense the sign of the operands used in Multiply and Divide operations and determine the sign of the result. Any negative operand must be complemented because the associated logic recognizes only positive numbers. The two SR FFs record the complemented operands.

The SR2 FF senses the signs of the operand in the Multiply or Divide operations and becomes enabled if it is negative and the corresponding conditions are met. The SR1 FF senses the sign of the operand in the X register and becomes enabled if it is negative and the corresponding conditions are met. The output from pin 26 goes to the Adder controls and enables the complementing of the negative operand.

Note that the SR1 FF senses the sign during Multiply operations and the SR1 and SR2 FFs sense the sign during Divide operations. The SR1 FF senses the sign of the quotient and the SR2 FF senses the sign of the remainder. The remainder maintains the sign of the dividend.
1
The output of pins 1 and 3 of the V65 module control the complementing of the product, quotient, and remainder. The condition Y00-04=0 signifies that shifting is completed (MUI or DVI instruction is finished) and the result is ready to be complemented if it is negative.

A Multiply instruction multiplies the contents of the storage location specified by the effective address by the contents of the A register. The 32 -bit product replaces the contents of $Q$ and $A$ with the most significant bits in the Q register. Bit Q15 is the sign bit.

The lower 5 bits of the $Y$ register hold the shift count that is set to $10{ }_{16}$ at the start of each Multiply instruction. The shift count is decremented by one before each shift operation.

The Adder/Shifter can shift a maximum of $16{ }_{10}$ bits (one register at a time). It is therefore necessary to have a bit bucket to hold the lowest order bit of the Q register during a shift that impliments both the A and Q registers ( 32 bits). During a Multiply instruction, the contents of QA are shifted right, end off, one place. The lowest order bit of the $Q$ register is placed in the bit bucket and the contents of the Q register are right shifted one place. The contents of the A register are then right shifted one place
with the contents of the bit bucket replacing bit position $A_{15}$. A more detailed description of the bit bucket logic is on page 56.1.

The Multiply bit (MB) is in bit position A00 during the first shift operation (A cycle) and is in bit position $A_{01}$ during the remaining ${ }^{15}{ }_{10}$ shift operations (C cycle). If MB $=0$, the contents of QA are right shifted in as previously described. If $M B=1$, the contents of the $X$ register (storage location specified by the effective address) are added to the contents of the $Q$ register and the sum replaces the contents of the $Q$ register. The contents of QA are then right shifted as previously described.

Below is an example of how the Multiply instruction operates.


During a Divide instruction the contents of the effective address ( $X$ register) is compared with the contents of the $Q$ register. If (X) $>(\mathrm{Q})$ a " 1 " enters EAB (End Around Borrow) and a " 0 " enters the bit bucket. A Long Left Shift shifts QA one place with the " 0 " in the bit bucket replacing bit position A00. Note that the bit bucket always contains the complement of the state of the EAB.

If $(\mathrm{X}) \leq(Q)$ a " 0 " enters EAB and a " 1 " enters the bit bucket. The contents of the $X$ register is subtracted from the contents of the $Q$ register and the difference enters the $Q$ register. A Long Left Shift shifts QA one place with the " 1 " in the bit bucket replacing bit position A00. In a QA shift, the $Q$ and $A$ registers are shifted separately since a maximum of 16 bits can be shifted at one time. Bit A15 replaces bit Q00 through the associated logic of the Adder/Shifter. A more detailed discussion of the logic of this process is on page 58.4.

This comparing and shifting process continues until the shift count reduces to zero. The shift count in the $Y$ register operates the same as in the previously described Multiply instruction.

## SHIFT, MUI AND DVI CONTROLS (Cont'd)

The Divide instruction divides the contents of $Q$ and $A$ registers with the contents of the effective address. The $Q$ register contains the most significant bits before execution. The quotient is in the A register and the remainder in the $Q$ register at the end of the Divide operation.

Below is an example of a Divide instruction.
Divide:

$$
\text { (X) } \begin{array}{cl} 
& (\mathrm{A}) \\
(\mathrm{QA)} & \mathrm{Q}=0 \\
& \begin{array}{l}
\mathrm{A}=272 \mathrm{E}_{16}=00100111.00101110_{2} \\
X
\end{array}=2_{16}
\end{array}
$$

| Q | A | Y | 1-2 |  | Bit Bucket |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 0000000000000000 | 0010011100101110 | F |  |  |  |
| 000 | 0100111001011100 |  | 1 | 0 |  |
| 000 |  |  | 1 | 0 |  |
| 001 | 1001110010111000 | D | 1 | 0 | $\left[\begin{array}{ll} \text { ex: } & Q \geq X \\ & E A B=0 \end{array}\right.$ |
|  | 0011100101110000 | C |  |  | Bit Bucket $=1$ |
| 010 |  |  | 0 | 1 | $(Q)=-010$ |
| 000 | 0111001011100001 | B | 1 | 0 | $(\mathrm{X})=-\frac{010}{000}$ |
|  | 1110010111000010 | A |  |  | $\overline{000}$ |
| 001 |  |  | 1 | 0 | [Replaces (Q) |
| 011 | 1100101110000100 | 9 | 0 | 1 |  |
| 001 | 1001011100001001 | 8 |  |  |  |
| 011 |  |  | 0 | 1 |  |
| 001 | 0010111000010011 | 7 |  |  |  |
| 010 |  |  | 0 | 1 |  |
| 000 | 0101110000100111 | 6 |  |  |  |
| 000 |  |  | 1 | 0 |  |
|  | 1011100001001110 | 5 |  |  |  |
| 001 |  |  | 1 | 0 |  |
|  | 0111000010011100 | 4 |  |  |  |
| 010 |  |  | 0 | 1 |  |
| 000 | 1110000100111001 | 3 |  |  |  |
| 001 |  |  | 1 | 0 |  |
|  | 1100001001110010 | 2 |  |  |  |
| 011 |  |  | 0 | 1 |  |
| 001 | 1000010011100101 | 1 |  |  |  |
| 011 |  |  | 0 | 1 |  |
| 001 | 0000100111001011 | 0 |  |  |  |
| 010 |  |  | 0 | 1 |  |
| 000 | 0001001110010111 |  |  |  |  |

The V73 module contains the Multiply Step, Multiply Bit, and Divide Step FFs. These three FFs enable the logic that controls the Multiply and Divide instructions.

The Multiply Bit FF senses bit location A00 during the A cycle and bit location A01 during the C cycle. If the sensed bit is a " 1 " and the corresponding conditions are present, the Multiply Bit FF sets and enables the logic that performs the adding of $(Q)$ and $(X)$ as previously described in the description of the multiply procedure.

The Multiply Step FF sets on the condition (MUI) (ROP) (050) (Y00-04 $\ddagger 0$ ) (C cycle). The Multiply Step FF enables the shifting and associated logic that performs a Multiply instruction. The Divide Step FF enables the shifting and associated logic that performs a Divide instruction.


The AQ I/O Channel operates in such a way that the $Q$ register of the computer contains the address of the peripheral device and the data transfer occurs to/from the A register of the computer.

INPUT ON AQ CHANNEL

A single word transfers to the A register whenever the computer executes the Input to A instruction ( $\mathrm{Q} 00=0$ ). The request for data by the computer is signified by a " 1 " signal on the Read line. The peripheral device whose address is in the Q register responds with a Reply when data is available to the A register.

If no data is available the peripheral device responds with a Reject. In either case the peripheral device must respond with a Reject or Reply within 4 microseconds. If no response is obtained in 6 microseconds the computer generates an internal Reject. Reply causes the computer to go to address $\mathrm{P}+1$. ( P is the address of the input instruction). Internal Reject causes the computer to go to address $P+\Delta$, where $\Delta$ is the lowest 8 bits of the input instruction, the highest of which is a sign bit. External Reject causes the computer to go to address $P+1+\Delta$.

## OUTPUT ON AQ CHANNEL

The output on $A Q$ operates similar to Input on AQ. The presence of the output data is signified by the presence of a " 1 " on the Write line. The responses are identical for input and output.

LOGIC FOR AQ I/O

Module V53 contains the Read FF for Input instructions and Write FF for output instructions. The " 0 " signal at pin 27 disables the computer timing chain when an Input or Output instruction is recognized.

The Read or Write signals enable transmitter circuits on the ZT module, a 7 usec delay on the V88 module, and a signal at pin 24 of the V74 module. The " 0 " output at pin 24 enables the computer timing chain when the following condition is present:

## (Read + Write)(Reply + Reject)

The Reply or Reject signals enter receiver circuits on a ZS module (location D20). These signals then set the appropriate FFs on module V74. If neither a Reject or Reply signal is received within 7 usec, an internal Reject is generated and the Reject FF sets.

The Character Input signal is received on a ZS module (location D12). This is a " 1 " signal sent to the computer during Input operations. If this signal is present during an Input to $A$ the lower 8 -bit character is loaded into the lower 8 bits of $A$ without disturbing the upper 8 bits of $A$.

## EXTERNAL INTERRUPT

Pins 26 and 28 of module V74 are external interrupt lines. These interrupts are OR'ed together in forming interrupt 01. The following figure shows the interrupt system including the 1705 option.


15 ADDITIONAL EXTERNAL INTERRUPT LINES (ADDS 14 INTERRUPTS)


TABLE 2. ZS MODULE CABLING

| Module Location | Pin | Destination | Module Location | Pin | Destination | Module Location | Pin | Destination | Module Location | Pin | Destination |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| D12 | 3 | J06-D2 | D15 | 3 | J02-D2 | D16 | 3 | J02-C6 | D17 | 3 | J02-B10 |
|  | 5 | J05-D2 |  | 5 | J01-D2 |  | 5 | J01-C6 |  | 5 | J01-B10 |
|  | 6 | J05-D1 |  | 6 | J01-D1 |  | 6 | J01-C5 |  | 6 | J01-B9 |
|  | 8 | J06-D1 |  | 8 | J02-D1 |  | 8 | J02-C5 |  | 8 | J02-B9 |
|  | 13 | J02-D8 |  | 13 | J02-C10 |  | 13 | J02-C4 |  | 13 | J02-B8 |
|  | 14 | J02-D7 |  | 14 | J02-C9 |  | 14 | J02-C3 |  | 14 | J02-B7 |
|  | 15 | J01-D8 |  | 15 | J01-C10 |  | 15 | J01-C4 |  | 15 | J01-B8 |
|  | 16 | J01-D7 |  | 16 | J01-C9 |  | 16 | J01-C3 |  | 16 | J01-B7 |
|  | 21 |  |  | 21 | J02-C7 |  | 21 | J02-C1 |  | 21 | J02-B5 |
|  | 23 |  |  | 23 | J01-C7 |  | 23 | J01-C1 |  | 23 | J01-B5 |
|  | 25 |  |  | 25 | J02-C8 |  | 25 | J02-C2 |  | 25 | J02-B6 |
|  | 27 |  |  | 27 | J01-C8 |  | 27 | J01-C2 |  | 27 | J01-B6 |


| Module <br> Location | Pin | Destination | Module <br> Location | Pin | Destination | Module <br> Location | Pin | Destination |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| D18 | 3 | J02-B4 | D19 | 3 | J02-A8 | D20 | 3 | J02-A2 |
|  | 5 | J01-B4 |  | 5 | J01-A8 |  | 5 | J01-A2 |
|  | 6 | J01-B3 |  | 6 | J01-A7 |  | 6 | J01-A1 |
|  | 8 | J02-B3 |  | 8 | J02-A7 |  | 8 | J02-A1 |
|  | 13 | J02-B2 |  | 13 | J02-A6 |  | 13 | J02-D6 |
|  | 14 | J02-B1 |  | 14 | J02-A5 |  | 14 | J02-D5 |
|  | 15 | J01-B2 |  | 15 | J01-A6 |  | 15 | J01-D6 |
|  | 16 | J01-B1 |  | 16 | J01-A5 | 16 | J01-D5 |  |
|  | 21 | J02-A9 |  | 21 | J02-A3 | 21 | J02-D3 |  |
|  | 23 | J01-A9 |  | 23 | J01-A3 | 23 | J01-D3 |  |
|  | 25 | J02-A10 |  | 25 | J02-A4 |  | 25 | J02-D4 |
|  | 27 | J01-A10 |  | 27 | J01-A4 |  | 27 | J01-D4 |

Q REGISTER


A REGISTER


## GENERAL INFORMATION

The 1700 storage consists of up to eight banks of magnetic core storage. Each bank contains 4096 locations for 18 -bit words. The format of the storage words is shown below.


The circuits for the eight banks are identical. The storage timing and control circuits select the storage bank from the translation of the three high-order stages of the address (S register).

The description of the storage circuits is based on bank 0 which is provided with the basic system. Unless otherwise stated, the description of the bank 0 storage circuits applies to the banks contained in any of the 1700 storage options.

Each storage bank consists of the storage stack, inhibit decks, and drive decks. The storage stack contains 18 planes of magnetic cores assembled in the conventional matrix arrangement.
Current-carrying wires pass through the cores and magnetize them in one direction or the other. The direction of current flow determines the direction of magnetization. Approximately 400 ma -turns of magnetizing force are needed to switch a core into one of its two stable states (" 1 " or " 0 "")

Five wires pass through each core. They are:

- A horizontal drive (x wire)
- A vertical drive (y wire)
- A horizontal inhibit ( $\mathrm{I}_{\mathrm{X}}$ wire)
- A vertical inhibit (Iy wire)

Coincident currents (one $x$ and one $y$ ) switch the cores. A core is addressed by simultaneously transmitting half-amplitude ( $200-\mathrm{ma}$ ) current pulses through a selected $x$ wire and a selected $y$ wire.

Only the core at the intersection of the selected $x$ and $y$ wires receives sufficient magnetizing current to switch its state. All other cores in the same row or column as the selected core receive half-amplitude current pulses which are not sufficient to switch the core. In Figure 11, if the left-most $y$ wire and the top $x$ wire carry current pulses, core A switches; cores B and C receive half-amplitude currents; and core D receives no current pulses.

The polarity of the residual magnetization determines the binary information in a core. The read current pulse on the selected $x$ or $y$ wire stores a " 0 ". The write pulse without a coincident current on the I wires stores a " 1 " in the core.


Figure 11. Portion of Magnetic Core Matrix
Applying a read pulse to the selected $x$ and $y$ wires reads information from the selected core. If the core previously stored a "1", the pulse switches the core to a " 0 ". This change induces a pulse on the $S$ wire. The pulse on the $S_{\text {" wire }}$ is in-
terpreted as a " 1 bit from the core. If the core previously stored a " 0 ", the read pulse does not affect it. Thus, no pulse is induced on the S wire.

One memory plane contains 4096 cores in a 64 -by- 64 array. Each bit of a word is stored in a separate plane. Thus, the stack contains 18 planes.

## MAGNETIC CORES

The magnetic cores used in the 1700 storage planes have two stable magnetic states " 1 " and " 0 ") because of the square hysteresis loop properties of the ferrite material. A current sufficient to cause enough flux density switches the core to positive or egative saturation density drops to the selual positive wr . Wen the cur " 0 " and the negative to " 1 "

If a core receives only a half-amplitude current, the core does not switch but remains in the residual state caused by the last coincident half-amplitude pulses.

Any change in the magnetic state of a core causes a change in the total flux linking the core and any winding passing through it. Such a change produces a voltage on the sense winding. During the time read current is applied, the output voltage is sampled to determine if the core switches. If a large voltage is sensed, the core was in the " 1 " state. If a small voltage is detected, the core was in the " 0 " state and merely shifted from the positive residual state to the positive saturation state

A common sense line threads through all 4096 cores in a storage plane. When reading, 64 x and 64 y cores contribute to the sense voltage. The total voltage induced by the 126 partially selected cores is less than the voltage induced on the nally through the cores in such a way that voltages from unselected cores tend to cancel.

## STORAGE PLANES

A storage plane is a 4-by-4-inch printed circuit board which holds 4096 cores in a 64 -by- 64 matrix. Five wires pass through each core. Figure 12 shows a simplified storage plane containing a 24-by-24 matrix; however, all the principles of this matrix apply to the larger matrix.

The wires that suspend the cores terminate on the inside edges of the board, and printed wiring carries the connections to the outside edges (top and bottom) for easier access. The 64 horizontal $x$ drive lines are brought to connections on each Figure 12 the even-numbered drive lines enter the plane from the DC edge and the odd-numbered lines from the AB edge. The letters at the corners of the plane in Figure 12fix the reference points of the plane in respect to the two views of the stack on the block diagram. The 64 vertical y drive lines enter the plane on the other edges in a similar manner. The sense line is a single line threading all the cores as shown in Figure 12. The two ends of the sense line terminate at one corner of the plane. Inhibit line connections enter the stack on the other three corners.
The inhibit lines are arranged in four vertical and four horizontal stripes or quadrants. Thus, the vertical inhibit lines run parallel to the $y$ drive lines and the horizontal parallel to the $x$ drive lines. The inhibit drive line for each stripe runs through 16 rows or columns of cores. During the write cycle ont with the write drive That one vertical inhibit stripe is energiz full inhibit drive in each plane drive. Thus, one $16-b y-16$ area of cores receives full inhibit drive in each plane
that corresponds to a " 0 " in the $Z$ register. The cores that receive full inhibit drive are prevented from switching to a " 1 ". Since the read drive pulse preceded the write and switched the reference core to a " 0 ", the full inhibit drive maintains the referenced core at the " 0 " state if the corresponding bit position of the word to be restored is a " 0 ".

The direction of inhibit current in the energized stripes is opposite to the x or y drive current of the write pulse, thus preventing the magnetization of the referenced core to the " 1 " state. For example, if write drive current enters the plane on lines $y 0$ and $x 0$ (Figure 12) and a " 0 " is to be stored in the plane, the 0 vertical and horizontal inhibit stripes are energized with current in the opposite direction. The contents of the $Z$ register select the planes that are to be inhibited. The address gized.


Figure 12. Simplified Storage Plane

STACK
The 18 storage planes are assembled into a stack as shown on the block diagram. A thin metal plate between each plane and on the top and bottom of the stack provides shielding and acts as a cold plate for cooling.

The $x$ and $y$ drive lines thread through the 18 planes as shown in Figure 13. The drive lines connect back to the drive deck. Each drive deck connects to 32 driv lines on the two sides of the stack as shown on the block diagram. The x and y drive decks are identical. The $y$ drive deck mounts on the top of the stack and the $x$ drive on the bottom.


Figure 13. X and Y Drive Lines

Consecutively numbered planes in the top half (nine planes) of the stack are rotated $00^{\circ}$ in respect to each other. For example, plane 1 is rotated $90^{\circ}$ counterclockwise in respect to plane 0 , etc. The bottom nine planes are also rotated $90^{\circ}$ in respect to each other. In this half, plane 16 is rotated $90^{\circ}$ in respect to plane 17. The rotation of planes gives a balance of connections at the corners of the stack.

One inhibit deck is mounted on each side of the stack and connects to the corners of he planes according to the horizontal and vertical stripe connection terminals at tripes 0 and 1 connect at corner B for planes $0,4,5,8$ etc Vertical inhibit stripes 2 and 3 connect to corner A for the same planes. Thus, inhibit.deck V21-2 connects to corners A and B for those planes as shown on the block diagram. The two types of inhibit decks (V21 and V20) differ only in the order of the inhibit stripes in the planes to which they connect.

## DRIVE DECKS

One drive deck supplies current to the x drive lines, and the other deck supplies current to the $y$ drive lines. The two decks are identical.
A deck has two printed circuit boards with printed wiring on both surfaces of the board. Components are mounted on and between the boards.

A deck contains a read and write current source and circuits to select each of the 64 drive lines.

## INHIBIT DECK

The four inhibit decks supply current to the horizontal and vertical inhibit lines. The inhibit decks are two types (V21 and V22), and differ only in printed wiring layout.

Inhibit lines on a plane are arranged in four 16-line groups in horizontal and vertical directions. Each deck has six current sources and circuits to select one of four groups on nine planes.

## ADDRESS SELECTION

The address at which a storage reference takes place is determined by the 15 bits in the $S$ register. The address is transmitted to the $S$ register from the $Y$ register at the beginning of the storage reference. The address in the $S$ register remains effective throughout the storage reference.

Bits 12, 13, and 14 of the address select the one of eight (maximum storage option) banks. If an attempt is made to reference a storage bank that is not plugged in, the same address is referenced in another bank that is plugged in. This wrap-around storage feature of the 1700 is described in detail in the $S$ register description (page 81).

The low -order 12 bits of the address select one of 64 x drive lines and one of 64 y drive lines during the read and write phases of the storage reference. Bits $0-5$ select the $y$ drive line, and bits $6-11$ select the $x$ drive line.

In the $y$ drive line selection, bits 1,2 , and 3 of the address select one of eight current source transformers on the y drive deck. Bits 0,4 , and 5 select one of eight current diverter circuits. The combination of these two selections selects one of 64 drive transformers on the $y$ drive deck which transmits the read and write current pulses through the corresponding $y$ drive line. The selection of the
$x$ drive line functions in an identical manner in the $x$ drive deck with bits 7,8 and $x$ drive line functions in an identical manner in the x drive deck with bits 7,8 , and
9 and bits 6,10 , and 11 respectively.

Bits 4 and 5 of the address also select one of four inhibit stripes on inhibit decks V20-2 and V21-2. Thus, the se inhibit decks select one of four vertical inhibit ripes on the corresponding planes. Bits 10 and 11 perform an identical function

## Z REGISTER

The sense line from each plane connects to a corresponding sense amplifier circuit. The sense amplifier circuit detects the switching of a core from the " 1 " to the " 0 " state. During the read phase of each storage reference, the output of the sense amplifiers transfers to the Z register. Thus, in the read phase, the Z register contains the word read from the stack.

In storage Read operations, the word in the Z register is later transferred to the X register. The word in the $Z$ register is then restored in the storage stack at the selected address during the write phase.

In storage Write operations, the word in the $Z$ register is replaced by the word transferred from the $X$ register. The new word in the $Z$ register is then stored at the selected address during the write phase.

## TIMING AND CONTROL

The timing and control circuit receives input Request Storage and Write signals from the external storage and computer accesses. The timing and control circuit in conjunction with the timing chain, then synchronizes and controls the entir and control circuit also performs such operations as bank selection, priority control between the external and computer storage requests, and transittin control between the external and computer storage requests, and transmitting the

## STORAGE BANK CONNECTORS

Each storage bank connects to the input, output, and control logic through four 30 -pin connectors. Thus, a storage stack simply plugs into the corresponding connectors on the chassis. The connectors are identified according to the same chassis coordinate system as the logic connectors. Inputs and outputs from the stack are shown on the logic diagrams in this manner. For example, the output of pin 14 on the V17 module at C23 (page 81) lists the destination as H08-9. Thus, this output connects to connector H8, pin 9

The storage module connector format is listed in Table 3. The table shows the format for bank 0. The format for the other banks is the same.
TABLE 3. 18-BIT STORAGE MOUULE CONNECTOR FORMAT

*Indicates twisted pair
**Storage module tester input


The 15-bit $S$ register contains the address of the current storage reference. The bit format of the S register is shown below.


The high-order three bits select the storage bank; bits $6-11$ select the $x$ drive line; and bits $0-5$ select the $y$ drive line. In addition, bits 4 and 5 select the vertical inhibit stripe, and bits 10 and 11 select the horizontal inhibit stripe.

The S register is contained on four V17 modules. The bit positions are arranged on the V17 modules for the convenience of the format shown above. Thus, each module contains two of the low-order drive-line bits, one of the inhibit-stripe bits, and one of the bank-selection bits. The high-order bit positions on the V17 module at the low -order three bits on each module and the corresponding fan-out modules go to the drive and inhibit decks where the address and inhibit stripe selection is made. The output of the bank-selection bits connects to the inputs of bank-selection module 1 (Z80).

The S register receives inputs from the 1705 external channel through the Address Receiver modules or from the computer Y register. The address is transferred to channel active enable or the computer channel active enable from storage timing and control gates the respective input into the $S$ register stages through the inverters on the V17 modules.

BANK SELECTION
Bits 12,13 , and 14 determine the storage bank selection. The $Z 80$ modules perform the bank selection. The selection of a given bank by the corresponding Z 80 module enables the Read and Write ( $R$ and W) drive signals to only that storage bank.
The bank selection circuit performs a wrap-around function in bank selection. For example, if the bank-designator bits attempt to select a storage bank not included in a particular system, the bank selection circuit selects an existing bank according to a fixed order of selection. The table below lists each passible storage option for a given bank designation.

If a particular module size does not exist in a system, pins $5,6,22$ and 1 receive $+1.2 \mathrm{v}\left({ }^{\prime} 0^{\prime \prime}\right)$ inputs. If the banks exist, the pins receive a grd' ("1") input. The input pins are grounded on the storage module connectors. For any storage bank option less than $20 \mathrm{~K}, \mathrm{Z} 80$ module 2 is removed.

As an example of storage bank selection, assume a bank designator of 6 and storage size of 20 K . In this case, pins $5,6,22$ and 1 in module 1 are grounded (" 1 " inputs). In module 2, pin 22 is grounded and pins 5, 6 and 1 receive " 0 " inputs (banks 5, 6, and 7 are not plugged in). Since the bank designator is 6 , pins 14, 13, and 12 on module 1 receive 110 inputs respectively. As a result all bank selection outputs of module 1 are disabled. In bank selection, a " 1 " output of the Z80 module disables the selection of the corresponding bank. The ACE AND input - in module 2 enables the following $R$ and ters for pins 10 and 12. These outputs provide Read and Write drive currents for bank 4, according to the table below.

BANK SELECTION TABLE

| $\begin{aligned} & \text { STORAGE } \\ & \text { SIZE } \end{aligned}$ | REMOVE MODULE | IN MOD 1 GND PIN | IN MOD 2 GND PIN |  |
| :---: | :---: | :---: | :---: | :---: |
| 4K | 2 |  |  | 0000000 |
| 8K | 2 | 1 |  | 01010101 |
| 12K | 2 | 1,6 |  | 01220122 |
| 16K | 2 | 1,5, 6 |  | 01230123 |
| 20K |  | 1,5,6,22 | 22 | 01234444 |
| 24K |  | 1, 5, 6, 22 | 1,22 | 01234545 |
| 28K |  | 1,5,6,22 | 1,6,22 | 01234566 |
| 32K |  | 1,5,6,22 | 1,5,6,22 | 01234567 |



The Z register serves as an intermediate storage for data being read from storage or being written into storage. The 18-bit $Z$ register is contained on nine V47 modules. The Z register and associated input and control logic is shown on pages tion of the $Z$ register is tion of the Z register is based on stages 0 and 1.

READ OPERATION
The $Z$ register receives inputs from the sense amplifiers on the read phase at approximately 475 nsec of the storage cycle. At this time, the output of inverter B gates the output of the sense amplifiers from the selected bank into $Z$. If a particular storage bank option (2-7) is present, the corresponding input to the $Z$ register or V84 fan-in module is grounded. For example, if bank 4 is plugged in, pin 14 is grounded ( 1 ) causing $C$ to enable the output of the bank 4 sense amplifiers. If a bank is not present, the corresponding input pins receive " 0 " inputs since the sense amplifier modules for that bank are not included with the system.

## Sense Amplifiers

The sense amplifiers for each bank are contained on three V02 modules. Each V02 module contains six sense amplifier stages. If a storage bank option is not included, the corresponding V02 modules are not plugged into the chassis.
The detection of a core switching from a " 1 " to a " 0 " in a storage plane induces a voltage on the sense line. This voltage appears as a " 1 " to the two inputs of the corresponding sense amplifier stage. Assuming the " 1 " was detected in plane 0 and bank 0 , stage 0 of the V02 module at E06 produces a " 1 " output at pin 3 . At
475 time of the storage cycle, the Read Strobe gates the " 1 " output of pin 3 into stage 0 of the $Z$ register.
The $Z$ register diagrams show only the sense amplifier stages for banks 0 and 7 . The table opposite page $85^{\circ} 1$ ists the locations, test point, and output pin informaThe table opposite page 85 lists the locations, test point, and
tion sense amplifier modules for all storage bank options.

## WRITE OPERATION

In a Write operation, the $Z$ register receives inputs from the 1705 direct storage access receivers or the computer $X$ register. If a 1705 option is included in the system, the receiver modules are plugged into the chassis. Thus, if an external storage write request is accepted by storage control, the Receivers $\rightarrow Z$ signal and the write strobe enable the transfer of the receiver outputs to the $Z$ register at 600 nsec of the storage cycle. If the computer write request is accepted, the $X \rightarrow Z$ transfer takes place athe same time. Lar in

## INHIBIT FAN-OUTS

Two inhibit fan-out modules connect to each stage of the Z register. The V87 modules provide inhibit inputs for banks 0 and 1, and the V86 module functions for
banks 2 through 7. The Inhibit enable which occurs at 675 nsec of the storage cycle gates the " 0 " state of the $Z$ register stages to the inhibit decks on all existing banks.

## PARITY GENERATOR

The parity generator circuit consists of two V18 modules. Each V18 module generates parity for nine $Z$ register stages. Both modules operate identically. Thus, the following description is based on the V18 module that generates parity for the loworder nine stages.

The V18 module generates parity based on three 3 -stage groups. The inverter inputs to each of the three groups examine the contents of the three stages for an odd combination of 1 bits. For example, if stages 0,1 , and 2 of the $Z$ register are all " 1 ' $s$ ", AND inputs $A, C$, and $E$ produce a 1 " output of $S$ indicating these stages contain an odd number of " 1 " bits. The output inverters examine the four possible odd combinations of the three groups. Thus, if the nine stages contain an odd number of bits, the corresponding output is a " 0 ". If the nine stages contain an
even number of " 1 " bits, all the outputs are " 1 's". even number of " 1 " bits, all the outputs are " 1 's".

## STAGES 16 AND 17

Stages 16 and 17 (page 99) function differently from the other stages. The sense amplifier inputs and control for these stages are the same as for the other stages. However, these stages do not receive inputs from the X register or the external receivers during a Write operation. The parity bit (stage 16) receives no inputs except from the sense amplifiers. However, the program protect bit (stage 17) is set by the following two other conditions:

1. (Write Protect) (t00) (Write Strobe) (Z17 = " 1 ")
2. (Write Protect) (t00) (Write Strobe) (F8)

In condition 1, the Write Protect function = (External Write) (External Channel. Active) [(External Protect) + (External Protect) (Parity Error) (Storage Protect Fault)] + (Computer Channel Active) (Computer Write) [Computer Protect + (Computer Protect) (Parity Error) (Storage Protect Fault)].

In condition 2, the Write Protect function $=(\overline{\text { Parity Error) }}$ ) (Storage Protect Fault) (Write Protect Bit = " 1 ") (Computer Channel Active). The Write Protect Bit FF is set during the computer REG mode in the SPB or CPB instructions with the Interrupt condition.

Thus, in condition 1, the Write Protect function enables the transfer of the previous state of Z17 back to stage 17 at 600 nsec of the storage cycle. In condition 2 , the Write Protect function enables the setting of stage 17 at 600 nsec on a SPB instruc tion (F8).


TABLE 4. SENSE AMPLIFIER AND DATA RECEIVER-TRANSMITTER LOCATIONS AND TEST POINTS

| Bit | DATAReceivers Transmitters |  |  |  |  | Bank 0 |  |  | Bank 1 |  |  | Bank 2 |  |  | Bank 3 |  |  | Bank 4 |  |  | Bank 5 |  |  | Bank 6 |  |  | Bank 7 |  |  | Bit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Inpu |  | Outp |  | Loc. | T. P.Out- <br> put <br> Pin |  |  | T. P.Out- <br> put <br> Pin |  | Loc. | T. P.Out- <br> put <br> Pin |  | Loc. | T. | Output Pin | Loc. | T. P.Out- <br> put <br> Pin |  | Loc. | T. P. | $\begin{array}{\|l\|} \hline \text { Out- } \\ \text { put } \\ \text { Pin } \\ \hline \end{array}$ | Loc. | T. P. | $\begin{array}{\|l\|} \hline \text { Out- } \\ \text { put } \\ \text { Pin } \\ \hline \end{array}$ | Loc. | T. P. | $\begin{aligned} & \text { Out- } \\ & \text { put } \\ & \text { Pin } \end{aligned}$ |  |
|  | Loc. | T. P. | Pin | T. P. | Pin |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| 0 | 1D07 | 1 | 7 | 2 | 10 | 1E06 | 1 | 3 | 1E12 | 1 | 3 | 1E22 | 1 | 3 | 1E25 | 1 | 3 | 1E34 | 1 | 3 | 1E43 | 1 | 3 | 1E50 | 1 | 3 | 1E57 | 1 | 3 | 0 |
| 1 |  | 4 | 17 | 3 | 12 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 | 1 |
| 2 | $\downarrow$ | 5 | 24 | 6 | 22 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 | 2 |
| 3 | 1D08 | 1 | 7 | 2 | 10 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 | 3 |
| 4 |  | 4 | 17 | 3 | 12 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 | 4 |
| 5 | $\downarrow$ | 5 | 24 | 6 | 22 | $\downarrow$ | 6 | 24 | $\checkmark$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | 5 |
| 6 | 1D09 | 1 | 7 | 2 | 10 | 1E07 | 1 | 3 | 1E13 | 1 | 3 | 1E23 | 1 | 3 | 1E26 | 1 | 3 | 1E35 | 1 | 3 | 1E44 | 1 | 3 | 1E54 | 1 | 3 | 1E58 | 1 | 3 | 6 |
| 7 |  | 4 | 17 | 3 | 12 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 | 7 |
| 8 | $\downarrow$ | 5 | 24 | 6 | 22 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 | 8 |
| 9 | 1D10 | 1 | 7 | 2 | 10 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 | 9 |
| 10 |  | 4 | 17 | 3 | 12 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 | 10 |
| 11 | $\downarrow$ | 5 | 24 | 6 | 22 | $\downarrow$ | 6 | 24 | $\checkmark$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | 11 |
| 12 | 1D11 | 1 | 7 | 2 | 10 | 1E08 | 1 | 3 | 1E14 | 1 | 3 | 1E24 | 1 | 3 | 1E27 | 1 | 3 | 1E36 | 1 | 3 | 1E45 | 1 | 3 | 1E56 | 1 | 3 | 1E59 | 1 | 3 | 12 |
| 13 |  | 4 | 17 | 3 | 12 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 |  | 2 | 4 | 13 |
| 14 | $\downarrow$ | 5 | 24 | 6 | 22 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 |  | 3 | 5 | 14 |
| 15 | 1D12 | 1 | 7 | 2 | 10 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 |  | 4 | 2 | 15 |
| 16 |  |  |  |  |  |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 |  | 5 | 25 | 16 |
| 17 |  |  |  |  |  | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | $\downarrow$ | 6 | 24 | 17 |



TABLE 5. ZS MODULE CABLING

| Module <br> Location | Pin | Destination | Module <br> Location | Pin | Destination | Module <br> Location | Pin | Destination |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| D07 | 3 | J06-A2 | D08 | 3 | J06-A8 | D09 | 3 | J06-B4 |
|  | 5 | J05-A2 |  | 5 | J05-A8 |  | 5 | J05-B4 |
|  | 6 | J05-A1 |  | 6 | J05-A7 |  | 6 | J05-B3 |
|  | 8 | J06-A1 |  | 8 | J06-A7 |  | 8 | J06-B3 |
|  | 13 | J06-A4 |  | 13 | J06-A10 |  | 13 | J06-B6 |
|  | 14 | J06-A3 |  | 14 | J06-A9 |  | 14 | J06-B5 |
|  | 15 | J05-A4 |  | 15 | J05-A10 |  | 15 | J05-B6 |
|  | 16 | J05-A3 |  | 16 | J05-A9 |  | 16 | J05-B5 |
|  | 21 | J06-A5 |  | 21 | J06-B1 |  | 21 | J06-B7 |
|  | 23 | J05-A5 |  | 23 | J05-B1 |  | 23 | J05-B7 |
|  | 25 | J06-A6 |  | 25 | J06-B2 |  | 25 | J06-B8 |
|  | 27 | J05-A6 |  | 27 | J05-B2 |  | 27 | J05-B8 |
|  |  |  |  |  |  |  |  |  |


| Module <br> Location | Pin | Destination | Module <br> Location | Pin | Destination |
| :---: | :---: | :---: | :---: | :---: | :---: |
| D10 | 3 | Jo6-B10 | D11 | 3 | J06-C6 |
|  | 5 | J05-B10 |  | 5 | J05-C6 |
|  | 6 | J05-B9 |  | 6 | J05-C5 |
|  | 8 | J06-B9 |  | 8 | J06-C5 |
|  | 13 | J06-C2 |  | 13 | J06-C8 |
|  | 14 | J06-C1 |  | 14 | J06-C7 |
|  | 15 | J05-C2 |  | 15 | J05-C8 |
|  | 16 | J05-C1 |  | 16 | J05-C7 |
|  | 21 | J06-C3 |  | 21 | J06-C9 |
|  | 23 | J05-C3 |  | 23 | J05-C9 |
|  | 25 | J06-C4 |  | 25 | J06-C10 |
|  | 27 | J05-C4 |  | 27 | J05-C10 |









## STORAGE INTERFACE

The storage interface module (V82) provides communication between compute control and storage timing and control. The V82 module contains the request storage, write, protect and parity fault outputs to internal interrupt, $Z \rightarrow X$, (Resume) and write protect bit controls.

## REQUEST STORAGE

The setting of the Request Storage FF by computer control initiates a complete storage cycle. The Request Storage FF remains set until the computer Resume號 until the Storage Busy condition is disabled at the end of the complete storage cycle.

The Request Storage FF is set at V050 time of the B cycle if under the following conditions:

$$
\text { (프mediate Operand }+ \text { RNI + Read Index) }
$$

WRITE
The Request Storage enable (I) sets the Write FF if a word is to be written in storage. Each Request Storage enable clears Write (H) before probing the se
conditions. The Write FF is set on the following conditions:

# ( Request Storage) [(ADR+REG) [(End Addressing) (STA+STQ+SPA+RTJ) + INT] 

 $+($ RAD $)($ ROP $)+$ Enter$Z \rightarrow X$
The Computer Resume signal sets the $Z \rightarrow X$ FF at 450 nsec of a storage reference. The actual $Z$ to $X$ register transfer does not take place until 500 nsec . The setting of the Write $F F$ blocks the $Z$ to $X$ transfer through inverter $F$.

## WRITE PROTECT BIT

he Computer Resume signal sets the Write Protect Bit FF in the REG mode of an SPB or CPB instruction if there is no inter rupt. The setting of this FF enable the setting of the Protect bit(Z17) on the SPB instruction and the clearing of the Protectbit on the CPB instruction.


|  | STORAGE INTERFACE | $\begin{array}{\|c} \text { Proouct } \\ 1704 \\ \hline \end{array}$ |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{aligned} & \text { OARVINO No. } \\ & 6015270 \end{aligned}$ |  |  |
| COMPUTER DIVISION |  |  | ${ }^{\text {suEET }}{ }^{\text {Pa }}$ | 1001 |  |

The storage timing chain circuits control the timing sequence of all storage cycle operations. The timing chain is contained on the V69 module with the input and output control circuits on the V89 and V93 modules.
The storage control circuit initiates the operation of the timing chain with the Start Timing Chain signal which sets K00. Flip-flops K00 through K05 sequentially
set and clear which produces the basic storage timing sequence. The timing chain goes through three complete sequences for each storage cycle.



The storage timing and control circuit controls such functions as Storage Access, Storage Protect Fault, Read, Write, Inhibit, Parity Bit, and Parity Fault. The timing chain sequences the control functions. The following paragraphs describe each of the main functions listed above with reference to the Storage Timing Chain (page 102)

## STORAGE ACCESS CONTROL

Storage access control functions take place on the V90 module. The request storage enable from the computer or external interface sets the corresponding Channel Active FF. The External Channel Active FF is set at t50 time. The Computer setting of either of the Channel Active FFs starts the timing chain and sets the Busy FF. The Busy FF blocks the Start Timing Chain output and the setting of the Channel Active FFs until Busy is cleared at the end of the present storage reference The setting of the Channel Active FF enables the gating of the corresponding address and data (Write only) into the S and Z registers respectively.

## STORAGE PROTECT FAULT CONTROL

The storage protect fault control is contained on the V94 module. The computer and external write and protect inputs enter this module. The state of the protect (Z17) is write and protect inputs enter this module. The state of that are active and the corresponding protect and write inputs are enabled.

Z17 equals " 1 ", the output of G sets the storage protect fault according to the following conditions:

EXTERNAL
STORAGE PROTECT FAULT $=(Z 17=" 1 ")(525 \mathrm{nsec})$ (EXTERNAL CHANNEL ACTIVE) (EXTERNAL WRITE) (EXTERNAL PROTECT)

## COMPUTER

STORAGE PROTECT FAULT $=($ Z17 $=$ " 1 " $)(525 \mathrm{nsec})$ (COMPUTER CHANNEL ACTIVE) (WRITE) [(INSTRUCTION PROTECTED (PROTECT SWITCH ACTIVE)]

The above equations show that the storage protect fault is detected if either the external or computer accesses attempt to write in a protected address. The setting f the Storage Protect Fault FF blocks the X to Z or Receivers to Z transfer and transmits the storage protect fault enable to the computer.

## READ, WRITE, AND INHIBIT CONTROL

The Read, Write, and Inhibit Control FFs enable the corresponding storage phase when set. These FFs are contained on the V91 module. These FFs are set at the proper times in the storage cycle according to the storage timing sequence page $10: 2$ )

PARITY BIT AND PARITY FAULT CONTROL
The parity bit and fault control is contained on the Z 78 module (page 107).

## Parity Bit Control

The writing of the parity bit in storage depends on the gate new parity enable from the V92 module. A new parity bit is written into storage under the following conditions:

> GATE NEW PARITY = [EXTERNAL PROTECT + (PARITY FAULT)
> (STORAGE PROTECT FAULT)] [(EXTERNAL CHANNEL ACTIVE)
> (EXTERNAL WRITE) $]+[(\overline{P A R I T Y}$ FAULT $)$ (STORAGE PROTECT
> FA $\overline{\text { PART }}$ ) (WRITE PROTECT BIT) (COMPUTER CHANNEL ACTIVE) $]+$

TECT) (WRITE) (COMPUTER CHANNEL ACTIVE)]
If any of the conditions in the above equation are satisfied, pin 5 of the $\mathbf{Z 7 8}$ module receives a " 0 " input. The outputs of the parity generator modules (V18) are sampled. If the total number of bits is odd, the Gate New Parity FF is not set and the inhibit fanouts receive a " 1 " input which stores a " 0 " in bit 16 . If the total number of bits is even, the inverse operation takes place.

## Parity Fault Detection

1 A parity fault is detected at the input inverters to the Parity Fault FF on the Z 78 module. The inputs to these inverters compare the parity generator outputs for the two halves of the word. If the two halves of the word (including parity bit) both contain an odd number of "1's", a parity fault is detected, and the Parity Fault FF is set. Likewise, if both halves contain an even number of bits, the Parity Fault FF is set. Thus, one-half of the word must contain an even number of " 1 's" and the other half must contain an odd number of "1's" due to the odd parity employed in the
data word.

The Parity Fault condition is transmitted to the computer where it is used in the internal interrupt and fault indicator circuits. A parity fault also blocks a write operation if the location is not protected.


When more than one piece of Equipment is connected to the Direct Storage Access (DSA) Bus, Cables must be correctly installed to insure proper operation of the Scanner. The attached Diagram shows three pieces of Equipnent using direct storage access, and the correct Cable connections for proper Scanner operation in the "First", "Mid", and "Last" settings. If any of the Cables are connected other than as shown, the Scanner will not function properly. Any change in Scanner priority will require the Equipment to be re-cabled to correspond with one of the examples shown. When the Scanner switch is dialed to "Out", that piece of Equipment is effectively removed from the DSA Bus, and the Scanner switches on all other Equipment must be changed to correspond with their new position on the DSA Bus.

${ }^{*}{ }_{\substack{\text { NOTE } \\ \text { NT" }}}$
T" indicates terminator



The two type MX drive decks control the selection of the x and y drive lines. The $y$ drive deck mounts on the top of the stack and the $x$ drive deck on the bottom. The two decks are physically and logically identical.

The low-order 6 bits of the address select the $y$ drive line, and the high-order 6 bits select the $x$ drive line, thus selecting one of 4096 cores in each plane. The following description applies specifically to the y drive deck. However, the descrip tion also applies to the x drive deck with the interchange of bit positions.

The drive circuits have separate primary read (RC) and write (WC) current sources, and both feed eight current transformers through a double primary winding circuit. These transformers provide eight current sources. Each source feeds one drive line transformer in each of eight groups. The drive transformer secondary winding
connects to the ends of the drive line which threads all 18 planes.

Each of eight diverter circuits feeds eight successive driver transformers. The selection of one of eight diverters diverts current to the proper drive line transformer and its drive line. Thus, a single current source is diverted to one of the 64 drive lines. Translations of S register bits 1, 2, and 3 select one of eight diverters.

Since both drive decks are turned on at the same time, a coincident current passes through one core in each plane.

The 64 drive transformers on each deck are so arranged that the 32 odd line trans ormers are on one edge and the 32 even are on the opposite edge (page 79). Thus, pposite sides of the deck drive successive lines. This arrangement provides an opposing current relationship with the inhibit drive lines.

## CURRENT SOURCE

The primary read or write current source consists of a large inductance connected between the +6 v supply and the eight current transformers. Transistor Q1 (and Q2) and its collector resistor (several in parallel) shunt current of about 250 ma to ground during non-write-or-read times. The load network keeps the power supply rive line transformer, approximately 200 ma pass through the drive line durin the storage cycle.

Bits 1, 2, and 3 of the address select one of eight transformers from a 2-by-4 transformer matrix. Bits 2 and 3 select one of four transformer groups, and bit 1 selects one of two in that group. The Read or Write Drive signal is combined with the one of two selection. The simplified drive and diverter circuits shown in the lower left-hand corner of the diagram assumes a --100-binary code in the 3 -bit drive position. The example also shows that transistors Q5 and Q6 turn off (shown as an AND) and Q7 turns on to select transformers T4 and T5 in the one of four group; transistors Q8 and Q9 turn off and Q3 turns on to select the read side of T4. Read load network transistor Q1 turns off, and current flows from ground to the +6 v source through transistors Q7 and Q3, transformer T4, diode CR1, and inductor L1.
A high impedance is presented to inductor L1 when read-load network transistor Q1 turns off, and the voltage level at the junction of diode CR1 and inductor L1 rises the latter limits the peak voltage at the junction to 15 v . Current loss in T4 is about 25 ma , so 225 ma flow in the secondary and is diverted to a drive transformer.

The circuit operates in a similar manner in the write cycle except that the polarities in the current transformer are reversed.

## DIVERTER CIRCUITS

The eight diverter circuits divert read and write current to the drive transformers. Each circuit feeds eight drive transformers, one for each current source transformer. Thus, the selected current source transformer drives eight lines and only one of the eight is diverted.
The diagram shows one of eight diverter circuits and its selection from the 3 address bits used for divert. The collectors of Q10, Q11, and Q12 feed the base of NPN transistor Q14 directly and the base of PNP transistor Q15 indirectly inia transistor Q13 which inverts the combined collector signal. The action establishes pusitive and negais established by the divider network of R01, C01, and diodes CR7, 8, and 9. The diode threshold is about 0.7 v for a combined drop of about 2.2 v and proper emitter bias.

The circuit operates in a similar manner in the write cycle except the polarities in the current transformers are reversed.


## INHIBIT DRIVE DECKS (TYPES V20 AND V21)

Four inhibit decks provide the inhibit current for the writing of a " 0 " in the corresponding plane. An inhibit deck is mounted on each of the four sides of the stack (page 79).

The inhibit lines in each plane are divided into four vertical and four horizontal stripes or quadrants. Each quadrant threads through 16 rows (horizontal) or columns (vertical) of cores. If a particular stage of the Z register contains a " 0 " at the time of the inhibit phase of the storage cycle, one horizontal and one vertical inhibit quadrant is energized in the corresponding plane simultaneously with the
write current. Thus, one 16-by-16 core portion of the plane receives full inhibit current. The quadrant that receives full inhibit current corresponds to the portion of the plane containing the selected core. S register bits 4 and 5 select the vertical inhibit quadrant and bits 10 and 11 select the horizontal quadrant.

Two types of inhibit decks are used, the V20 and V21. The two types differ only in the order of inhibit quadrant connections. There are two of each type mounted on the stack. The tables on the diagram list the inhibit decks and the $Z$ register and S register connections.


TRANSFERS

The table below shows the register transfers necessary in forming the 32 possible effective address modes. The storage reference instructions contain three fields: Instruction, Address Mode, and Delta. The format of the storage reference instruction is shown in the lower right hand corner. The effective address is formed by setting various combinations of the four address mode bits and delta. Delta is a signed 8-bit address modifier where the most significant bit (bit 7) is the sign bit.

The computer assembles the effective address in the following order if the corresponding address flag is set.

1) checks $r$ and $\Delta$ and forms $P+\Delta, P+1$ or $\Delta$.
2) checks ind and completes indirect addressing.
3) checks $q$ and adds the contents of the $Q$ register.
4) checks $i$ and adds the contents of storage location 00 FF .

notes
1. $\mathbf{r}=\mathrm{F}_{11}{ }^{- \text {RELATIVE ADORESS ing }}$
2. ind $=F_{1,1}$ - INDIRECT Adoress ing

- $q=F_{i}$ - USE Q REGISTER AS INDEX

4. $i=F_{8}$ - USE ADDRESS OOFF ( $3.7{ }_{8}$ ) AS INDEX
s. Parentheses used in the effective adoress inoicate "contents of ",


STORAGE REFERENCE FORMAT


## STO TRANSFERS

The following table shows the transfers and commands necessary for instructions using the Store Operand mode (STO). Storage is requested at time B050 for every STO instruction.

The sequence paths for entering and exiting STO mode are shown below:


STORE OPERAND MODE (STO)


## REG TRANSFERS

The following table shows the transfers and commands necessary for instructions using the Register Transfer mode (REG). The table is especially useful for showing the absence of certain conditions and transfers during the execution of the listed instructions. For example, at time B100 the Adder $\longrightarrow Y$, P transfer is not used for the EXI, SPB and CPB instructions. Also, note that a C cycle occurs during a Shift instruction when the shift count $\neq 0$.

The sequence paths for entering and exiting the REG mode are shown below :



The following table shows the transfers and commands necessary for instructions using the Read Operand mode (ROP). At time A000 the computer receives a Storage Resume signal and at time B050 storage is requested. Note that a C cycle occurs during the ROP mode for MUI and DVI instructions.

The sequence paths for entering and exiting the ROP mode are shown below:




## C CYCLE TRANSFERS

The following table shows the transfers and commands necessary during the C cycle of Shift, MUI, and DVI instructions. Time 150 occurs 100 nsec early for Shift and MUI instructions when the short cycle through the Adder/Shifter is used. This effectively reduces the Adder/Shifter
time from 200 nsec to 100 nsec. A DVI instruction uses the complete Adder/Shifter and therefore does not use the short cycle.

If $\mathrm{Y} 00-04 \neq 0$ at the end of the C cycle, the C cycle is repeated. If Y00-04 $=0$ at the end of the C cycle, the B cycle is initiated.



## POWER AND CABLING

The following diagrams may be found in the 1700 Site Preparation manual. Pub. No. 60158400.

Power Distribution, 50 Cycle Internal M-G.
Power Distribution, 60 Cycle Internal M-G.
Typical 1700 System Using Both Internal and External M-G Sets.
Typical 1700 System Using an External M-G Set.



| C- CONTROL DATA | TiTLEMONITOR PANELASSEMBLY AIVERTICAL AUXILIARY CABINET | ${ }^{\text {reobucr }} 170$ |  |
| :---: | :---: | :---: | :---: |
|  |  |  | $0{ }^{\text {nev }}$ |
| COMPUTER DIVISION |  | $\left.\right\|^{\text {Petet }}$ | 131 |






.






BLOWER ASSEMBLY
148
Rev AB




MA INTENANCE

PREVENTIVE MAINTENANCE INDEX

| Level 1 ---------------------------------------------- Weekly |  |  |
| :---: | :---: | :---: |
| Level 2 ------------------------------------------- Monthly |  |  |
| Level 3 ------------------------------------------- 6 Months |  |  |
| $\begin{aligned} & \text { LEVEL } \end{aligned}$ | ITEM | PREVENTIVE MAINTENANCE |
|  | 0.1 | Preliminary Information |
| X* | 2.1 | Clean Air Filters |
| X | 2.2 | Check Logic Voltages |
| X | 2.3 | Check Indicators |
| ${ }_{\text {X }} \mathrm{X}$ | 2.4 | Check Console Controls |
| X X | 2.5 2.6 | Run Diagnostics (Margins Applied) Check Logic Voltages |
| X | 3.1 | Perform Shock Testing (Memory Stacks and Sense Amps) |
| X | 3.2 | Check Indicators |
| X | 3.3 | Check Emergency Off - On |
| X | 3.4 | Run Diagnostics (Logic Voltage Margins Applied) |
| X | 3.5 | Perform Shock Testing |

*Level 1 if necessary.

## MARGIN TABLE

| CONDITIONS | LOGIC VOLTAGE |  | DRIVE | INHIBIT | CLOCK <br>  <br> $\|$CO |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Normal | Normal |  | Normal | Normal |
| 2 | $+10 \%$ | $+10 \%$ | Normal | Normal | Normal |
| 3 | $-10 \%$ | $-10 \%$ | Normal | Normal | Normal |
| 4 | Normal | Normal | Normal | Normal | $+10 \%$ |
| 5 | Normal | Normal | Normal | Normal | $-10 \%$ |

## NOTES

1. Where level 2 or level 3 PM procedures overlap level 1 or level 2 procedures, only the highest level procedures need be performed.
2. Shock testing (Item 2.1) should be performed using the standard AMP insertion tool with the special nylon shock testing tip ( $\mathrm{P} / \mathrm{N}$ 12209308).
2.1

## CHECK/Conditions

1. System power on.

CLEAN AIR FILTERS

## Action

1. Remove each of the bottom air filters from both of the air filter compartments (base of the 1704).
2. If the filter is not extremely dirty, it may be cleaned with a vacuum cleaner. If required, the filter should be washed gently in a detergent - water solution. Place the filter vertically while washing to avoid damaging it.
3. Replace corroded filters with new filters.
4. Replace the new or clean filter on top of the filters still in each filter compartment.

## CHECK/Conditions <br> Action

1. System power on.
+6 VOLT LOGIC SUPPLY
2. Depress the +6 volt
button on the memory
power supply.
CHECK: Does the percent-
age meter read $0 \%$ ?

|  | $\longrightarrow 1$. Adjust the +6 volts. <br> 2. Repeat CHECK. <br> -6 VOLT LOGIC SUPPLY |
| :---: | :---: |
| Depress the -6 volt |  |
| button on the memory |  |
| power supply. |  |

CHECK: Does the percent-
age meter read $0 \%$ ?


## CHECK INDICATORS

## NOTE

## The 1700 Computer Reference Manual explains in detail the operation and indication of all console switches and bit switches. This manual should be readily available for reference while completing these CHECKS. In the event that a given switch, indicator or display does not perform properly, isolate and correct the problem.

## CHECK/Conditions <br> Action

1. System power on.
2. While manually operating all bit switches and display switches, complete the following:

CHECK: Do all the bit
switches set and clear all
six (6) register displays
correctly without sticking or
binding?
Yes No $\longrightarrow$. Take appropriate action.
2. Correct discrepancy.
3. Repeat CHECK.

CHECK: Are all the Drive
and Inhibit lights on the
memory stacks lit?


## CHECK/Conditions

1. System power on.
2. While performing the operations listed in Item
3. 5 (Run Diagnostics;

Condition 1 only).
CHECK: Do the console toggle
switches operate correctly?
(Reference: 1700 Computer
Reference Manual) (Reference:
SMM Manual).


NOTE


#### Abstract

Use an accurate D. C. Voltmeter when setting margins. On a rotational basis, run all operational tests under all conditions as set forth below, such that all conditions are covered at least once a month. DO NOT PERFORM MARGIN TEST WHILE COMPUTER IS ACTIVELY MONITORING ANY PROCESS CONTROL FUNCTION.


TABLE 1

| 1. | SMM17 | Command Test |
| :--- | :--- | :--- | (3 Passes)

## CHECK/Conditions

Action

1. System power on.
2. With logic voltages at condition 1 (see margin
table; item 0.1, Preliminary
information).
3. Run all tests in Table 1 and -
4. Correct any errors.
5. Set margins at condition 2 (see margin table).

6. Run all tests in Table 1 (excluding the memory test) and -
7. Correct any errors.
2.5 (Continued)
CHECK/Conditions
Action
8. Determine the best operatingpoint for each memory stack,as per the procedure inrevision $E$ of the 1700
Maintenance Manual.
NOTE
Step 5 may be omitted if previously
performed, and if the margins in
Step 6 have not deteriorated from
those found previously.
CHECK: Does each stack have at
least 1.0 volt drive swing at the
best operating point?
${ }_{\downarrow}^{\text {Yes }}$ No $\longrightarrow 1$ 1. Correct by replacing defective module or stack.
9. After the stacks have beenadjusted to their best opera-ting point, determine themass memory margins byvarying the mass memorypots while running the worstpattern of the 1700 SMM
memory test. Record these
margins (from the meter onthe power supply) for futurereference.

## CHECK/Conditions

## Action

1. System power on.
2. Ensure that the +16 volt
memory bus bar - is at
least +16 volts.
3. Ensure that the +8 volt
memory bus bar - is at
least +8 volts.
4. Use your most accurate D. C.

Voltmeter to check the +6
volt logic voltage setting.
Ensure that the percentage
meter says $0 \%$ when the actual measured voltage is
+6.0 volts.
CHECK: Is the percentage meter
zeroed with a +6 volt setting?

| Yes No $\longrightarrow 1$. | To zero the percentage meter, remove <br> the memory power supply access panel. |
| :--- | :--- |
| Adjust the correct potentiometer on the <br> printed circuit board (upper left hand <br> corner of the power supply). |  |
| $\qquad$ | 2.Replace access panel. |
|  | 3. $\quad$ Repeat CHECK |

5. Use your most accurate D. C.

Voltmeter to check the -6 volt
logic voltage setting: Ensure
that the percentage meter says
$0 \%$ when the actual measured
voltage is -6.0 volts.

## 2.6 (Continued)

## CHECK/Conditions <br> Action

CHECK: Is the percentage meter
zeroed with a -6 volt setting?

| Yes No $\longrightarrow 1$. | To zero the percentage meter: Remove <br> the memory power supply access panel. <br> Adjust the correct potentiometer on the |
| :--- | :--- |
| printed circuit board (upper left hand <br> corner of the power supply). |  |
| Go to next item. | 2. |

# NOTE <br> DO NOT PERFORM SHOCK TEST WHILE COMPUTER IS ACTIVELY MONITORING ANY PROCESS CONTROL FUNCTION. 

## CHECK/Conditions <br> Action

1. System power on.
2. Load and execute the SMM17 Memory Test. Select parameters to test one stack at a time.
3. While monitoring test, shock test the selected memory sense amp module and memory stack (use shock test tip).

CHECK: Is test still running?

| Yes | No $\longrightarrow$ | Repair or replace shock sensitive <br> module or stack. |
| :--- | :--- | :--- |
|  | 2. | Repeat CHECK. |

4. Go back to Step 2 and select the next stack.
5. System power on.

OVERFLOW, PROGRAM PROTECT, PARITY ERROR
2. All console switches to neutral.

Set the ENTER switch. Enter
${ }^{0901}{ }_{(16)}$ in the $\dot{X}$ register.
3. Place computer in run.

Do not step or clear the
computer until Step 6 has been completed.
4. Return ENTER switch to neutral.

CHECK: Did the overflow light
come on?

| Yes | No $\longrightarrow$ | 1. |
| :--- | :--- | :--- |
|  |  |  |
| $\downarrow$ | Isolate and correct problem. | Repeat CHECK. |

5. Set the ENTER switch again.

Set the PROGRAM PROTECT
switch.

## CHECK: Is the Program Protect

Fault Light Lit?

6. Return ENTER switch to neutral.
Return the PROGRAM
PROTECT switch to neutral.

## 3.2 (Continued)

## CHECK/Conditions

## Action

Ground B21, test point 6.
CHECK: Is the Parity Error
Light Lit?

```
Yes No \(\longrightarrow 1\). Isolate and correct problem.
                                    2. Repeat CHECK.
```

INSTRUCTION, INDIRECT ADDRESS, STORAGE INDEX, OPERAND

1. Enter C501 (16) in
memory at $P=0000$.
Enter 0000 (16) in
memory at $\mathrm{P}=0001$.
Enter 0000 (16) in
memory at $\mathrm{P}=00 \mathrm{FF}$.
2. Master clear.
3. All toggle switches in neutral.

CHECK: Are the Instruction and
Program Protect Bit lights lit?

4. Depress the STEP switch once.

## CHECK: Does the INDIRECT

Address light come on?

| Yes | No $\longrightarrow$ | Isolate and correct problem. |
| :--- | :--- | :--- |
| $\downarrow$ | 2. | Repeat CHECK. |

5. Depress the STEP switch once.

## 3.2 (Continued)

## CHECK/Conditions <br> Action

CHECK: Does the Storage Index
light come on?

6. Depress the STEP switch once.

## CHECK: Does the Operand light

come on?

CHECK/Conditions Action

1. System power on.
2. No program in operation.
3. Verify that the EMERGENCY OFF switch works correctly.

# NOTE <br> Use an accurate D. C. Voltmeter when setting margins. On a rotational basis, run the Command Test under the conditions listed, such that all conditions are covered at least once each six months. <br> DO NOT PERFORM MARGIN TESTS WHILE COMPUTER IS ACTIVELY MONITORING ANY PROCESS CONTROL FUNCTION. 

## CHECK/Conditions <br> Action

1. System power on.
2. Load and execute the SMM17

Command Test (three passes for each of the conditions listed).
a. Condition 2
(Ref. Margin Table:
Item 0.1, preliminary
information)
b. Condition 3
(Ref. Margin Table)
c. Condition 4
(Ref. Margin Table)
d. Condition 5
(Ref. Margin Table)
CHECK: Does the Command Test
successfully run three passes
under each of the four marginal
conditions?


## NOTE

Schedule shock testing on a rotational basis so that each module is completed once each six months.

## CHECK/Conditions <br> Action

1. System power on.
2. D. C. Chassis Voltages
a. +6 volts
b. -6 volts
3. Storage Drive Margins
a. Normal
4. Clock frequency
a. Normal
5. Load and execute the

SMM17 Command Test
with parameters selected for 100 operands.
6. While monitoring test -

Shock test each module
(use shock test tip).
CHECK: Does the Command
Test run successfully?

| $\mathrm{Yes} \mathrm{No} \longrightarrow$ | 1. |
| ---: | :--- |
|  | Isolate and correct. |
|  | 2. |
|  | Repeat CHECK. |

### 3.5 Continued

## CHECK/Conditions <br> Action

7. Load and execute SMM

17 program protect test.
8. While monitoring test,
shock test each module.
CHECK: Does Program Protect
Test run successfully?


## APPENDIX A

## INSTRUCTION FLOW CHARTS

## This appendix contains flow charts that show the steps in execution of the following instructions.

## - Shift Instructions

ARS - A Right Shift
ALS - A Left Shift
QRS - Q Right Shift
QLS - Q Left Shift
LRS - Long Right Shift (QA Shift, Right)
LLS - Long Left Shift (QA Shift, Left)

- Multiply

MUI - Multiply Integer

- Divide

DVI - Divide Integer


## 1700 COMPUTER SHIFT OPERATIONS-ALL SHIFTS





## 1700 COMPUTER SHIFT OPERATIONS ALL SHIFTS


*SHORT CYCLE 2 PRESENT BECAUSE SHIFT CYCLE F/F IS SET.
SC2 BLOCKS H06 AND H07; ENABLES
H00 (PAGE 7)

## 1700 COMPUTER SHIFT OPERATIONS



## 1700 COMPUTER SHIFT OPERATIONS

## A REGISTER SHIFTS


OPERATIONS COMPUTER SHIFT
Q SHIFTS

## 



IDENTICAL WITH
1700
1700 COMPUTER SHIFT OPERATIONS
Q SHIFTS
IDENTICAL WITH PAGE 3 OF A SHIFTS BUT WITH
Q REGISTER

## 1700 COMPUTER SHIFT OPERATIONS

Q SHIFTS<br>IDENTICAL WITH PAGE 4 OF A SHIFTS BUT WITH Q REGISTER



## 1700 COMPUTER SHIFT OPERATIONS QA SHIFTS



## 1700 COMPUTER SHIFT OPERATIONS <br> ALL SHIFTS

$$
\text { WV } \Lambda ə \mathrm{Y} \quad I I-\forall
$$



## 1700 COMPUTER SHIFT OPERATIONS ALL SHIFTS



$$
\begin{aligned}
& 1700 \text { MULTIPLY } \\
& \text { OPERATIONS }
\end{aligned}
$$

## 1700 COMPUTER MULTIPLY OPERATION <br> THIS FLOW CHART BEGINS AT T50 OF THE LAST B CYCLE OF ADDRESSING



## 1700 COMPUTER MULTIPLY OPERATION



## 1700 COMPUTER MULTIPLY OPERATION




## 1700 COMPUTER MULTIPLY OPERATION



## 1700 COMPUTER MULTIPLY OPERATION



## 1700 COMPUTER MULTIPLY OPERATION



NO SHORT CYCLE
NORMAL TIMING

## 1700 COMPUTER MULTIPLY OPERATION



## 1700 COMPUTER MULTIPLY OPERATION




## 1700 COMPUTER DIVIDE OPERATION <br> QA MUST CONTAIN THE DIVIDEND BEFORE EXECUTION OF A DIVIDE INSTRUCTION. THIS FLOWCHART BEGINS AT T50 OF THE LAST B CYCLE OF ADDRESSING.



## 1700 COMPUTER DIVIDE OPERATION



## 1700 COMPUTER DIVIDE OPERATION



Subtract

## 1700 COMPUTER DIVIDE OPERATION



## 1700 COMPUTER DIVIDE OPERATION



## 1700 COMPUTER DIVIDE OPERATION



## APPENDIX B

TECH TIPS AND INSTALLATION CHECKOUT

## 1700 MEMORY PROBLEMS



Also, there are four (4) screws holding each Drive Deck and each Inhibit Deck to the stack frame. These screws should also be checked for tightness.

## 1700 VANE SWITCHES


#### Abstract

Any 1700 sites having problems with the vane switches in the blower assemblies may short the switch contacts eliminating the switch from the circuit. New 1704's are being built without the vane switch.


### 1.700 MEMORY STACK INHIBIT INDICATOR

Frequently when 1700 systems are powered on, one or more of the memory stack inhibit voltage indicators does not light. This condition is normal since the indicator is tied into the inhibit overload circuit. The transients that occur during a power on sequence may cause a momentary overload on the inhibit circuit and prevent the inhibit power from coming on. The "no inhibit voltage" condition may be corrected by master clearing the computer from the console if all circuits are operating normally.

## 1700 MEMORIES

When installing FCO CA 19317 (modified 1700 memory stacks), it is mandatory that the operating points of the stack be determined as per the procedure on page 1-12 of the 1700 Maintenance Manual, Pub. No. 60160400.<br>When returning a defective memory stack to Customer Engineering Materials, attach a defective parts tag to the handle on the stack. Describe the defect in detail, and include such information as intermittent, solid, etc. If the problem is intermittent, how often does it fail?

## MEMORY CHECKING AND ADJUSTMENT PROCEDURE

## ADJUSTMENT OF MEMORY OPERATING POINT

To adjust the lower 4K, run the SMM17 (Test-2) memory test normally using only the worst pattern test section. To adjust the remainder of memory, the test parameters may be set up to run the worst pattern section only in the storage module being adjusted. Insert stack in system and allow. 5 hour for stack to stabilize at system temperature. Set drive to 12.0 volts and inhibit to 4.6 volts. The stack should run at this point if the ambient temperature is between $70^{\circ}$ to $90^{\circ} \mathrm{F}$. If the ambient temperature is not between $70^{\circ}$ to $90^{\circ} \mathrm{F}$, check Figure 2 and adjust the drive voltage accordingly for the starting point of the schmoo. Adjust the inhibit voltage up in steps of 0.4 volt while varying the drive voltage through its entire operating range at each step. Plot the upper and lower operating limits at each inhibit point. Continue until the maximum operating limit on the inhibit voltage is reached. Return the inhibit voltage to its original setting and follow the same procedure taking the inhibit voltage down in steps of 0.4 volt until the minimum operating limit on the inhibit voltage is reached. Pick a point in the center of the resulting schmoo as the operating point and adjust the drive and inhibit voltages accordingly (Figure 1). If at this point the drive voltage swing is less than 1.0 volt, the stack should be tried in another location and the above procedure repeated. If the drive margin is still less than one 1.0 volt, the stack should be rejected.

## TEMPERATURE CHARACTERISTICS OF MEMORY SCHMOO

Ambient temperature changes drastically affect the memory operating point of the stack (Figure 2). For a constant inhibit voltage, the stack drive voltage must change with temperature. The stack does contain an internal temperature compensating circuit but may not track the center of the curve shown in Figure 2. Therefore, if a site experiences severe temperature extremes or changes, the optimum operating point may have to be determined at the high temperature extreme experienced.


Figure 1

Example


Figure 2

## EST ABLISHING AND CHECKING MEMORY MARGINS

After proper operating points have been set for each storage module present in the system tighten both lock nuts. Check memory margins by using the mass drive and inhibit adjustments. These adjustments vary the regulated drive and inhibit voltages on all storage modules simultaneously whenever the MARGIN MODE switch is ON.

The percentage voltmeter on the memory power supply is used to monitor the change in regulated drive and inhibit voltages when the mass-drive and mass inhibit adjust potentiometers are varied. Percentages at which failures occur vary with the number of storage modules in the computer and the ambient temperature. Therefore, the percentage voltmeter does not measure true percentages in regulated drive and inhibit voltages. The percentage at which memory margin tests are to be made must be established separately at each installation. (Example: at $70^{\circ} \mathrm{F}$, reasonable memory margins occur when both drive and inhibit voltages vary $\pm 0.4$ volt from their optimum values. The percentage readings at which this occurs would be recorded and used for future margin testing. ) Margin testing should be done with only one voltage at a time varied from its normal setting. This procedure was followed prior to final test and shipment. Once percentage voltmeter figures for mass drive and inhibit changes have been established for the system, a preventive maintenance check of memory margins requires only that the MARGIN MODE switch and mass adjust potentiometers be used. The establishing of new percentage voltmeter readings is necessary if additional storage modules are added to the computer, the ambient temperature has changed significantly, or if it is suspect that memory is causing errors.

## $17 O D$ MEMORY STACK OSCILLATION PRORIFM

1700 memory stacks should be checked for ripple greater than 300 millivolts on the inhibit test point. If the ripple is more than 300 millivolts, remove the stack and check the inhibit regulator board mounting screws for tightness. If the screws are tight, loosen and re-tighten them. Replace the stack and check the ripple again. If it is still greater than 300 millivolts, the stack should be rejected.

## MUFFIN FANS

[^1]
## 1704 CONSOLE GROUNDING

At many sites it is possible to hang-up or deep-end the 1704 by touching different switches or buttons on the console. This is caused by a static discharge through the switches which are not grounded.

The problem may be eliminated by grounding the switches as illustrated below.


## ADJUSTMENT PROCEDURE

Applies To: All Equipment Using 1700 Memory Stacks

1700 Memory Stack Part Number 18419300 has been replaced by 53618700 (gold connectors) and 53618701 (silver connectors). The new stacks are directly interchangeable with the old, with one exception. The new stack will not function in the 1704 if the mass margin switch is turned on. FCO CA31812 has been written to permit the use of the new stack in the 1704. This FCO disables the mass margin mode and should be installed when the first new type stack is installed. A new stack can be installed without this FCO; however, mass margins cannot be used since it forces the regulators to their low end, resulting in parity errors. The FCO consists of adding the following wires:

| $1 \mathrm{H} 63-17$ | $1 \mathrm{H} 63-\mathrm{X}$ | $2^{\prime \prime}$ |
| :--- | :--- | :--- |
| $1 \mathrm{H} 58-29$ | $1 \mathrm{H} 58-\mathrm{X}$ | $2^{\prime \prime}$ |

New stacks may be identified by the protective guide rails on the bottom and the drive deck air deflectors.

The following procedure is to be used when adjusting the new stacks. It should be noted that the stacks are factory adjusted and need not be readjusted immediately upon installation. However, a schmoo should be made after an initial 8-hour warm-up period and used for future reference to determine stack degradation.

## MEMORY CHECKING AND ADJUSTMENT PROCEDURE

## NOTE

This stack has been tested and set at $120^{\circ} \mathrm{F}$ and the adjust potentiometers have been sealed. This setting is good for any temperature from $40^{\circ} \mathrm{F}$ to $120^{\circ} \mathrm{F}$. The seals may be broken to check operating point but should be returned to original values to maintain a setting which is good over the entire temperature range. If a change in the setting is made, it should be made when the system is at the highest temperature that it will encounter. No adjustment shall be made if the power has not been on for at least the previous 8 hours.

[^2]
## ADJUSTMENT OF MEMORY OPERATING POINT

This procedure refers to 1700 SMM17 diagnostic. If the stack is being installed in other equipment, an equivalent test must be used.

To adjust the lower 4 K , run the SMM17, Test-2 or Test-12, memory test normally using only the worst pattern test section. To adjust the remainder of memory, the test parameters may be set up to run the worst pattern section only in the storage module being adjusted. Set drive to 8.0 volts and inhibit to 4.6 volts. The stack should run at this point if the ambient temperature is between $70^{\circ}$ to $90^{\circ} \mathrm{F}$. If the ambient temperature is not between $70^{\circ}$ to $90^{\circ} \mathrm{F}$, check Figure 2 and adjust the drive voltage accordingly for the starting point of the schmoo. Adjust the inhibit voltage up in steps of 0.4 volt while varying the drive voltage through its entire operating range at each step. Plot the upper and lower operating limits at each inhibit point. Continue until the maximum operating limit on the inhibit voltage is reached. Return the inhibit voltage to its original setting and follow the same procedure taking the inhibit voltage down in steps of 0.4 volt until the minimum operating limit on the inhibit voltage is reached. Pick a point in the center of the resulting schmoo as the operating point and adjust the drive and inhibit voltages accordingly (Figure 1). A drive voltage operating range of less than 1.0 volt is unacceptable. If the range is unacceptable, the cause should be isolated to the stack assembly by moving the stack to at least one other position in the system and repeating the above procedure. If the problem disappears then the problem is likely to be in the memory interface circuitry for that position.

## EFFECT OF TEMPERATURE ON MEMORY OPERATING POINT

Ambient temperature changes drastically affect the memory operating point of the stack. * The stack contains an internal temperature compensation circuit which causes the drive and inhibit voltages to change as temperature changes. Consequently, any adjustments made to the stack must be made at a constant temperature.

As temperature increases the drive and inhibit operating ranges become smaller. Thus, making the settings on the stack at the highest temperature that will be experienced by the system will provide the best setting for the temperature tracking circuitry. This is the reason that the factory settings are made at $120^{\circ} \mathrm{F}$.

[^3]| Regulated <br> Drive <br> Voltage |
| :--- |
| O.0 |

Figure 1


Figure 2
$3 \mathrm{O}, 60 \mathrm{~Hz}$
1704A COMPUTER SYSTEM INSTALLATION CHECKOUT

## NOTE

Before beginning checkout, read this entire procedure thoroughly.

Before applying 60 Hz or 400 Hz power to the equipment, check the power input terminal block TB7 in the power distribution box A7 and TB1 on the MG assembly A8, with an ohmmeter to ensure there are no shorts present. Turn on A11 circuit breakers before taking this reading. The resistance reading will be low due to the low dc resistance of the variac primaries in assemblies A5 and A6.

To ensure that the 1704A Computer System will function properly, perform the following checkout for the 3 -phase, 60 Hz configuration.
A. Pre-Power Checks 60 or 400 Hz not applied to the 1704A Computer System.

1. Check all power wiring for proper installation and tight connections into the input terminal blocks in the power distribution box and the MG assembly.
2. Turn off CB1 in the memory power supply A6 and CB1 in the MG assembly A8.
3. Turn T1, T2 variacs in the memory power supply counterclockwise to STOP.
B. Power Distribution Power-On Procedure
4. Ensure that the 60 Hz and the 400 Hz power is available from the breaker panel on the wall.
5. With a voltmeter, check to see if 120 volts is present at TB8, terminals 1 and 2, and 24 volts is present at terminals 3 and 4.
6. With a voltmeter, check to see if 208 volts is present at TB7, terminals 2 and 3, 3 and 4 and that 120 volts is present at terminals 1 and 2,1 and 3 , and 1 and 4.
7. Energize CB1 in MG assembly A8.
8. Press the on switch; at this time the blowers in assemblies A5 and A6 should start up. Also, power should be present at memory power supply terminal block TB1. Power is also present at TB10 and TB4; also the power on light should illuminate.
C. Memory Power Supply Power-On Procedure
9. Check TB1, to see if power is present.
10. Turn CB1 on; at this time +8 VDC should be present at W3 and +16 VDC should be present at W1.
D. Logic Power Supply Power-On Procedure
11. Variac T1 and T2 are in assembly A6, the memory power supply.
12. While monitoring W3, turn variac T2 up until -6 VDC is present at this bus bar.
13. While monitoring W1, turn variac T1 up until +6 VDC is present at this bus bar.

To ensure that the 1704 A Computer System warning and protection circuitry will function properly, perform the following checkout.

## NOTE

To avoid unnecessary power interrupts, it is recommended that verification be accomplished on scheduled power shutdowns with a maximum of 6 months between verifications.
A. Temperature Warning Indication

1. With a heat generating device (preferably a calibrated heat gun) heat up the temperature warning thermostat $\mathrm{S} 2115^{\circ}$. This will give a temperature warning indication by making the temperature warning light illuminate.
2. With the blowers running in assemblies A5 and A6, depress the vane switch. This will cause the temperature warning light to illuminate. Release the vane switch; the light goes out.
B. High Temperature Indicating Test
3. With a heat generating device (preferably a calibrated heat gun) heat up the high temperature thermostat $\mathrm{S} 1125^{\circ}$. This will cause power to cease, and make the high temperature light illuminate. When thermostat cools down power should return to the system when the off switch is pressed and then the on switch is pressed.
C. Emergency Off Test
4. With the 1704A Computer System running, press the emergency off switch. Power should cease to the computer system.
5. To restart the system, press the on switch.

WARNING
This test should not be made more than three times in a 1 hour period.
$3 \mathrm{O}, 50 \mathrm{~Hz}$
1704A COMPUTER SYSTEM INSTALLATION CHECKOUT

NOTE
Before beginning checkout, read this entire procedure thoroughly.

Before applying 50 Hz or 400 Hz power to the equipment, check the power input terminal block TB7 in the power distribution box A7 and TB1•on the MG assembly A8, with an ohmmeter to ensure there are no shorts present. Turn on A11 circuit breakers before taking this reading. The resistance reading will be low due to the low de resistance of the variac primaries in assemblies A5 and A6.

To ensure that the 1704 A Computer System will function properly perform the following checkout for the 3 -phase, 50 Hz configuration.
A. Pre-power Checks 50 or 400 Hz not applied to the 1704 A Computer System.

1. Check all power wiring for proper installation and tight connections into the input terminal blocks in the power distribution box and the MG assembly.
2. Turn off CB1 in the memory power supply A6 and CB1 in the MG assembly A8.
3. Turn T1, T2 variacs in the memory power supply counterclockwise to STOP.

## B. Power Distribution Power-On Procedure

1. Ensure that the 50 Hz and the 400 Hz power is available from the breaker panel on the wall.
2. With a voltmeter, check to see if 230 volts is present at TB8, terminals 1 and 2, and 24 volts is present at terminals 3 and 4 .
3. With a voltmeter, check to see if 398 volts is present at TB7 terminals 2 and 3, 3 and 4 and that 230 volts is present at terminals 1 and 2, 1 and 3 , and 1 and 4.
4. Energize CB1 in MIG assembly A8.
5. Press the on switch; at this time the blowers in assemblies A5 and A6 should start up. Also, power should be present at the memory power supply terminal block TB1. Power is also present at TB10 and TB4; also, the power-on light should illuminate.

## C. Memory Power Supply Power-On Procedure

1. Check TB1 to see if power is present.
2. Turn CB1 on; at this time +8 VDC should be present at W 3 and +16 VDC should be present at W1.
D. Logic Power Supply Power-On Procedure
3. Variac T1 and T2 are in assembly A6, the memory power supply.
4. While monitoring W3, turn variac T2 up until -6 VDC is present at this bus bar.
5. While monitoring W1, turn variac T1 up until +6 VDC is present at this bus bar.

To ensure that the 1704A Computer System warning and protection circuitry will function properly, perform the following checkout.

NOTE
To avoid unnecessary power interrupts, it is recommended that verification be accomplished on scheduled power shutdowns with a maximum of 6 months between verifications.
A. Temperature Warning Indication

1. With a heat generating device (preferably a calibrated heat gun) heat up the temperature warning thermostat $\mathrm{S} 2115^{\circ}$. This will give a temperature warning indication by making the temperature warning light illuminate.
2. With the blowers running in assemblies A5 and A6, depress the vane switch. This will cause the temperature warning light to illuminate. Release the vane switch, light goes out.
B. High Temperature Indicating Test
3. With a heat generating device (preferably a calibrated heat gun) heat up the high temperature thermostat $\mathrm{S} 1125^{\circ}$. This will cause power to cease and make the high temperature light to illuminate. When thermostat cools down, power should return to the system when the off switch is pressed and then the on switch is pressed.

## C. Emergency Off Test

1. With the 1704 A Computer System running, press the emergency off switch. Power should cease to the complete system.
2. To restart system, press the on switch.

## WARNING

This test should not be made more than three times in a 1 hour period.
$3 \mathrm{O}, 60 \mathrm{~Hz}$
1704B COMPUTER SYSTEM INSTALLATION CHECKOUT

NOTE
Before beginning checkout, read this entire procedure thoroughly.

Before applying 60 Hz or 400 Hz power to the equipment, check the power input terminal block TB7 in the power distribution box A7 and TB1. on the MG assembly A8, with an ohmmeter to ensure there are no shorts present. Turn on all circuit breakers before taking this reading. The resistance reading will be low due to the low dc resistance of the variac primaries in assemblies A5 and A6.

To ensure that the 1704B Computer System will function properly, perform the following checkout for the 3 -phase, 60 Hz configuration.
A. Pre-Power Checks 60 or 400 Hz not applied to the 1704 B Computer System.

1. Check all power wiring for proper installation and tight connections into the input terminal blocks in the power distribution box and the MG assembly.
2. Turn off CB1 in the memory power supply and A6 and CB1 in the MG assembly A8.
3. Turn T1, T2 variac in the memory power supply counterclockwise to STOP.
B. Power Distribution Power-On Procedure
4. Ensure that the 60 Hz and the 400 Hz power is available from the breaker panel on the wall.
5. With a voltmeter, check to see if 120 volts is present at TB8 terminals 1 and 2, and 24 volts is present at terminals 3 and 4.
6. With a voltmeter, check to see if 208 volts is present at TB7, terminals 2 and 3, 3 and 4 and that 120 volts is present at terminals 1 and 2, 1 and 3, and 1 and 4 .
7. Energize CB1 in MG assembly A8.
8. Press the on switch; at this time the blowers in assemblies A5 and A6 should start up. Also, power should be present at the memory power supply terminal block TB1. Power is also present at TB10 and TB4, also, the power-on light should illuminate.
C. Memory Power Supply Power-On Procedure
9. Check TB1 to see if power is present.
10. Turn CB1 on; at this time +8 VDC should be present at W 3 , and +16 VDC should be present at W1.
D. Logic Power Supply Power-On Procedure
11. Variac T1 and T2 are in assembly A6, the memory power supply.
12. While monitoring W3, turn variac T2 up until -6 VDC is present at this bus bar.
13. While monitoring W1, turn variac T1 up until +6 VDC is present at this bus bar.

To ensure that the 1704 B computer system warning and protection circuitry will function properly, perform the following checkout.

## NOTE

To avoid unnecessary power interrupts, it is recommended that verification be accomplished on scheduled power shutdowns with a maximum of 6 months between verifications.
A. Temperature Warning Indication

1. With a heat generating device (preferably a calibrated heat gun) heat up the temperature warning thermostat $\mathrm{S} 2115^{\circ}$. This will give a temperature warning indication by making the temperature warning light illuminate.
B. High Temperature Indicating Test
2. With the blowers running in assemblies A5 and A6, depress the vane switch. This will cause all power to cease, and make the high temperature light illuminate. Release the vane switch, power should return when the off switch is pressed and then the on switch is pressed.
3. With a heat generating device (preferably a calibrated heat gun) heat up the high temperature thermostat $\mathrm{S} 1125^{\circ}$. This will also cause power to cease and make the high temperature light to illuminate. When the thermostat cools down, power should return to the system when the off switch is pressed and the on switch is pressed.
C. Emergency Off Test
4. With the 1704B Computer System running, press the emergency off switch. Power should cease to the complete system.
5. To restart the system, press the on switch.

## WARNING

This test should not be made more than three times in a 1 hour period.

# $3 \mathrm{O}, 50 \mathrm{~Hz}$ <br> 1704B COMPUTER SYSTEM INSTALLATION CHECKOUT 

NOTE
Before beginning checkout, read this entire procedure thoroughly.

Before applying 50 Hz or 400 Hz power to the equipment, check the power input terminal block TB7 in the power distribution box A7 and TB1 and the MG assembly A8, with an ohmmeter to ensure there are no shorts present. Turn on all circuit breakers before taking this reading. The resistance reading will be low due to the low dc resistance of the variac primaries in assemblies A5 and A6.

To ensure that the 1704 B computer system will function properly, perform the following checkout for the 3 -phase, 50 Hz configuration:
A. Pre-Power Checks 50 or 400 Hz not applied to the 1704 B Computer System.

1. Check all power wiring for proper installation and tight connections into the input terminal blocks in the power distribution box and the MG assembly.
2. Turn off CB1 in the memory power supply $A 6$ and CB1 in the MG assembly A8.
3. Turn T1, T2 variac in the memory power supply counterclockwise to STOP.

## B. Power Distribution Power-On Procedure

1. Ensure that the 50 Hz and the 400 Hz power is available from the breaker panel on the wall.
2. With a voltmeter, check to see if 230 volts is present at TB8 terminals 1 and 2, and 24 volts is present at terminals 3 and 4.
3. With a voltmeter, check to see if 398 volts is present at TB7, terminals 2 and 3, 3 and 4 and that 230 volts is present at terminals 1 and 2, 1 and 3, 1 and 4 .
4. Energize CB1 in the MG assembly A8.
5. Press the on switch; at this time the blowers in assemblies A5 and A6 should start up. Also, power should be present at the memory power supply terminal block TB1. Power is also present at TB10 and TB4, also, the power on light should illuminate.
C. Memory Power Supply Power-On Procedure
6. Check TB1 to see if power is present.
7. Turn CB1 on; at this time +8 VDC should be present at W3, and +16 VDC should be present at W1.
D. Logic Power Supply Power-On Procedure
8. Variac T1 and T2 are in Assembly A6, the memory power supply.
9. While monitoring W3, turn variac T2 up until -6 VDC is present at this bus bar.
10. While monitoring $W 1$, turn variac $T 1$ up until +6 VDC is present at this bus bar.

To ensure that the 1704B Computer System warning and protection circuitry will function properly, perform the following checkout.

NOTE
To avoid unnecessary power interrupts, it is recommended that verification be accomplished on scheduled power shutdowns with a maximum of 6 months between verifications.
A. Temperature Warning Indication

1. With a heat generating device (preferably a calibrated heat gun) heat up the temperature warning thermostat $\mathrm{S} 2115^{\circ}$. This will give a temperature warning indication by making the temperature warning light illuminate.
B. High Temperature Indicating Test
2. With the blowers running in assemblies A5 and A6, depress the vane switch. This will cause all power to cease and make the high temperature light illuminate.
Release the vane switch, power should return when the off switch is pressed and then the on switch is pressed.
3. With a heat generating device (preferably a calibrated heat gun) heat up the high temperature thermostat $\mathrm{S} 1125^{\circ}$. This will also cause power to cease and make the high temperature light to illuminate. When the thermostat cools down, power should return to the system when the off switch is pressed and then the on switch is pressed.

## C. Emergency Off Test

1. With the 1704 B Computer System running, press the emergency off switch. Power should cease to the complete system.
2. To restart system, press the on switch.

WARNING
This test should not be made more than three times in a 1 hour period.

## COMMENT SHEET



## COMMENTS:

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>>> CUT OUT FOR USE AS LOOSE-LEAF BINDER TItLE TAB


[^0]:    Address comments concerning this manual to:

    Control Data Corporation Technical Publications Department 4201 North Lexington Avenue
    St. Paul, Minnesota 55112
    or use Comment Sheet in the back of
    this manual.

[^1]:    Some equipments fail due to overheating caused by muffin fan failure. To prevent this, check all muffin fans about every two months. Stop the fan and manually rotate the blades. They should spin freely without a trace of binding or high friction. If they do not rotate smoothly and freely, replace the muffin fan.

[^2]:    If there is a mixture of this stack (PN 53618700 or 53618701 ) and the older stack (PN 18419300 or 24362700 ) in the system, the mass memory adjust capability cannot be used. Margin testing will then have to be done on an individual stack basis. Also, if the system has entirely stacks 53618700 and/or 53618701 , the mass adjust cannot be used if the mass adjust capability is the type used to adjust stacks 18419300 and 24362700 .

[^3]:    * Drive voltage change approximately 0.03 volt per $\mathrm{F}^{\mathrm{O}}$ change in temperature. Inhibit voltage change approximately 0.01 volt per $\mathrm{F}^{\mathrm{o}}$ change in temperature. Voltages increase as temperature decreases.

